

Nemko Korea CO., Ltd.

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FCC EVALUATION REPORT FOR CERTIFICATION

Applicant :**Samsung Electronics Co., Ltd.****314, Maetan3-Dong, Youngtong-Gu,****Suwon-Shi, Kyunggi-Do, Korea.****(Post code : 442-743)****Attn. : Mr. Min-ho Kim****Dates of Issue : Sep 15, 2005****Test Report No. : NK2FR171****Test Site : Nemko Korea Co., Ltd.****EMC site, Korea****FCC ID*****A3LSIT200EMRB*****Brand Name*****SAMSUNG*****CONTACT PERSON****Samsung Electronics Co., Ltd.****314, Maetan3-Dong, Youngtong-Gu, Suwon-Shi,****Kyunggi-Do, Korea, 442-743.****Mr. Min-ho Kim****Telephone No. : +82-016-230-4248****Applied Standard:****FCC 47 CFR Part 15, Subpart C : 2004****Classification :****FCC Class B Device****EUT Type:****OfficeServ SOHO**

The device bearing the brand name and model specified above has been shown to comply with the applicable technical standards as indicated in the measurement report and was tested in accordance with the measurement procedures specified in ANSI C63.4-2003.

I attest to the accuracy of data and all measurements reported herein were performed by me or were made under my supervision and are correct to the best of my knowledge and belief. I assume full responsibility for the completeness of these measurements and vouch for the qualifications of all persons taking them.

**Tested By : M.C.Shin****Senior Engineer****Reviewed By : H.H. Kim****Manager & Chief Engineer**

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SCOPE

Measurement and determination of electromagnetic emissions (EME) of radio frequency devices including intentional and/or unintentional radiators for compliance with the technical rules and regulations of the Federal Communications Commission under FCC part 15.

Responsible Party :	Samsung Electronics Co., Ltd.
Contact Person :	Mr. Min-ho Kim
Manufacturer :	Samsung Electronics Co., Ltd. 314, Maetan3-Dong, Youngtong-Gu, Suwon-Shi, Kyunggi-Do, Korea

- FCC ID: A3LSIT200EMRB
- Model: SIT200EMRB
- Brand Name: SAMSUNG
- EUT Type: OfficeServ SOHO
- Classification: FCC Class B
- Applied Standard: FCC 47 CFR Part 15 , Subpart C
- Test Procedure(s): ANSI C63.4 (2003)
- Dates of Test: Sept 1, 2005 ~ Sept 14, 2005
- Place of Tests: Nemko Korea Co., Ltd. EMC Site
- Test Report No.: NK2FR171

INTRODUCTION

The measurement procedure described in American National Standard for Methods of Measurement of Radio-Noise Emissions from Low-Voltage Electrical and Electronic Equipment in the Range of 9kHz to 40GHz (ANSI C63.4-2003) was used in determining radiated and conducted emissions emanating from **Samsung Electronics Co., Ltd.**

FCC ID : **A3LSIT200EMRB**

These measurement tests were conducted at **Nemko Korea Co., Ltd. EMC Laboratory**.

The site address is 300-2, Osan-Ri, Mohyun-Myun, Yongin-City, Kyungki-Do, KOREA

The area of Nemko Korea Corporation Ltd. EMC Test Site is located in a mountain area at 80 kilometers (48 miles) southeast and Incheon International Airport (Incheon Airport), 30 kilometers (18miles) south-southeast from central Seoul.

It is located in the valley surrounded by mountains in all directions where ambient radio signal conditions are quiet and a favorable area to measure the radio frequency interference on open field test site for the computing and ISM devices manufactures.

The detailed description of the measurement facility was found to be in compliance with the requirements of § 2.948 according to ANSI C63.4 2003.



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EMC Lab.
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City Kyungki-Do, KOREA 449-852
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Fig. 1. The map above shows the Seoul in Korea vicinity area.

The map also shows Nemko Korea Corporation Ltd. EMC Lab. and Incheon Airport.

TEST CONDITIONS & EUT INFORMATION

Operating During Test

The EUT was connected to the local area network and the public switched telecommunications network.

The test was performed sending and receiving a voice data and loop-back mode of a data packet.

Support Equipment

OfficeServ SOHO (EUT)	Samsung Electronics Co., Ltd., FCC ID: A3LSIT200EMRB 2.0m unshielded Ethernet cable 2.0m unshielded WAN cable 2.0m unshielded Line 1(RJ-11) cable 2.0m unshielded Line 2(RJ-11) cable AC/DC Adaptor : Ault Inc. Model: PW118KA0500N58 1.8m unshielded AC power cable 1.5m Shielded DC power cable	S/N: N/A S/N: N/A
PC	Dell Computer Corporation, Model: WHL-2(Precision 530) 1.5m Unshielded AC power cable	S/N: N/A
LCD Monitor	Hansol LCD Inc., Model : B17DF 1.8m shielded D-sub cable 1.8m unshielded AC power cable	S/N: N/A
Keyboard	Dell Computer Corporation, Model:SK-8110 1.6m Unshielded Din cable	S/N: N/A
PS/2 Mouse	Microsoft Corporation, Model: Intelli Mouse 1.6m unshielded Din cable	S/N: N/A
Serial Mouse	ALLSPIRIT, Model : WS-V1-400 1.5m Shielded D-Sub cable	S/N:B050402
Printer	Epson Korea, Model : EPSON STYLUS C80 1.7m Shielded Parallel cable 1.8m Unshielded AC power cable	S/N: D3FE005162
Telephone	LG Electronics, Model : GS-472 2.0m Unshielded modular(RJ-11) cable	S/N:70306385
HUB	3COM, Model : Dual Speed Switch 16 2.0m Unshielded Modular Jack Cable AULT INC. Model : 7900-000-046-1-00 1.8m Unshielded DC power cable	S/N: N/A S/N: N/A

EUT Information

Clock	32.768KHz(Y2), 4.096MHz(Y7,Y10), 33.33MHz(Y12), 20MHz(Y5), 25MHz(Y13,Y14)
Clock(RF Card)	40MHz(Y1)
Chipset	U25(PCF8563), U40(VP101X12CQC), U32(D36561), U102,U103(ADM7001), U11(YMU762C-QZE2)
Chipset(RF Card)	U1(AR2413)
RF Frequency(Center Frequency)	2412 ~ 2462MHz (11 CH)
RF output power	Maximum of 19dBm
Size(with stand)	270(width) X 155(length) X 80(height)mm
Weight	0.9Kg
Power	AC/DC adaptor (100-250V/5V)

SUMMARY OF TEST RESULTS

The EUT has been tested according to the following specification:

Name of Test	Paragraph No.	Result	Remark
Power line Conducted Emission	15.207	Complies	
Radiated Emission (Spurious)	15.209	Complies	
Modulated Bandwidth (6dB Bandwidth)	15.247(a)(2)	Complies	
Peak Power Output	15.247(b)	Complies	
Conducted Spurious Emission	15.247(c)	Complies	
Radiated Spurious Emission	15.247(c)	Complies	
Power Spectral Density	15.247(d)	Complies	
Maximum Permissible Exposure	1.1307(b)	Complies	

RECOMMENDATION/CONCLUSION

The data collected shows that the **Samsung Electronics Co., Ltd.**

FCC ID : **A3LSIT200EMRB**

The highest emission observed was at **196.6 MHz** for radiated emissions with a margin of **17.6 dB**.

SAMPLE CALCULATION

$$\text{dB}\mu\text{V} = 20 \log_{10} (\mu\text{V}/\text{m})$$

$$\mu\text{V} = 10^{(\text{dB}\mu\text{V}/20)}$$

EX. 1.

@57.7 MHz

Class B limit = 100 $\mu\text{V}/\text{m}$ = 40.0 dB $\mu\text{V}/\text{m}$

Reading = 19.1 dB μV (calibrated level)

Antenna factor + Cable Loss + Amplifier Gain = 10.12 dB

Total = 29.22 dB $\mu\text{V}/\text{m}$

Margin = 40.0 – 29.22 = 10.78

10.78 dB below the limit

DESCRIPTION OF TESTS

Radiated Emissions

Preliminary measurement were made indoors at 3 meter using broad band antennas, broadband amplifier, and spectrum analyzer to determine the frequency producing the maximum EME. Appropriate precaution was taken to ensure that all EME from the EUT were maximized and investigated. The Technology configuration, clock speed, mode of operation or video resolution, turntable azimuth with respect to the antenna was note for each frequency found.

The spectrum was scanned from 27 to 1000MHz using Biconical log Antenna(ARA, LPB-2520/A). Above 1GHz, Doppels Teg Horn antenna (EMCO, DAA-37121:upto 1~18GHz) was used.

Final Measurements were made outdoors at 3 or 10m test range using Logbicon Super Antenna(Schwarzbeck, VULB9166) or Doppels Teg Horn antenna.(EMCO, DAA-37121) The test equipment was placed on a wooden table.

Sufficient time for the EUT, support equipment, and test equipment was allowed in order for them to warm up to their normal operating condition.

Each frequency found during pre-scan measurements was reexamined and investigated using EMI test receiver.(ESCS30)

The detector function was set to CISPR peak mode or quasi-peak mode or average mode and the bandwidth of the receiver was set to 120KHz or 1MHz depending on the frequency or type of signal.

The half wave dipole antenna was tuned to the frequency found during preliminary radiated measurements.

The EUT support equipment and interconnecting cables were re configured to the setup producing the maximum emission for the frequency and were placed on top of a 0.8m high non- metallic 1.0X 1.5 meter table.

The EUT, support equipment and interconnecting cables were re-arranged and manipulated to maximize each EME emission.

The turn table containing the Technology was rotated; the antenna height was varied 1 to 4meter and stopped at the azimuth or height producing the maximum emission Each emission was maximized by : switching power lines; varying the mode of operation or resolution; clock or data exchange speed; scrolling H pattern to the EUT and of support equipment, and powering the monitor from the floor mounted outlet box and computer aux AC outlet, if applicable; which ever determined the worst case emission.

Each EME reported was calibrated using the R/S signal generator.

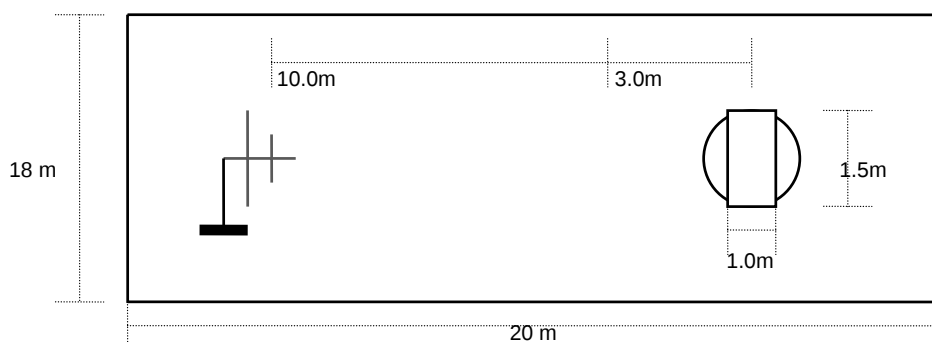
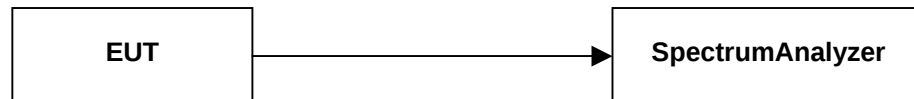


Fig. 2. Dimensions of Outdoor Test Site

DESCRIPTION OF TESTS

Modulated Bandwidth (6dB Bandwidth)

Test Setup



Test Procedure

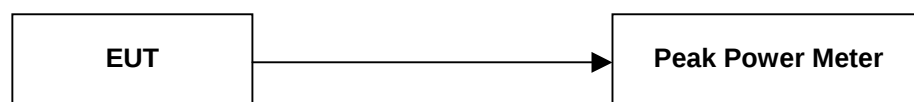
The transmitter is connected to the spectrum analyzer.

The RBW of spectrum analyzer is set to 100KHz and VBW is set to the 100KHz.

The sweep time is coupled.

Peak Power Output

Test Setup



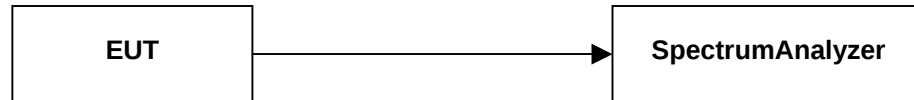
Test Procedure

The transmitter is connected to the Peak power meter.

DESCRIPTION OF TESTS

Conducted Spurious Emission

Test Setup



Test Procedure

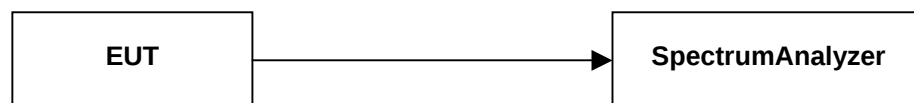
The transmitter is connected to the spectrum analyzer.

The RBW of spectrum analyzer is set to 100KHz and VBW is set to the 100KHz.

Measurements are made over the 30MHz to 26.5GHz range with the transmitter set to the Lowest, Middle, and highest channels within the 2.4GHz band.

Peak Power Spectral Density

Test Setup



Test Procedure

The transmitter is connected to the Spectrum analyzer.

The maximum level in a 3KHz bandwidth is measured with the spectrum analyzer.

The RBW of spectrum analyzer is set to 3KHz and VBW is set to 10KHz.

The sweep time is set to Span/3KHz and video averaging is turned off.

The PPSD is the highest level found across the emission in any 3KHz band.

TEST DATA

Conducted Emissions

FCC ID : A3LSIT200EMRB

Frequency (MHz)	Level(dB μ V)		Line	Limit(dB μ V)		Margin(dB)	
	Q-Peak	Average		Q-Peak	Average	Q-Peak	Average
0.20	55.1	43.2	N	63.6	53.6	8.5	10.4
0.26	45.1	36.5	N	61.4	51.4	16.3	14.9
0.33	41.3	33.2	N	59.5	49.5	18.2	16.3
0.47	38.8	35.5	L	56.5	46.5	17.7	11.0
0.73	39.0	36.8	L	56.0	46.0	17.0	9.2
1.54	37.5	33.6	L	56.0	46.0	18.5	12.4

Table 1. Line Conducted Emissions Tabulated Data

NOTES:

1. Measurements using CISPR quasi-peak mode & average mode.
2. All modes of operation were investigated and the worst -case emission are reported. See attached Plots.
3. LINE : L =Line , N = Neutral
4. The limit is on the FCC Part section 15.207(a).



Tested by **M. C. Shin**

PLOTS OF EMISSIONS

Conducted Emission at the Mains port (Line)

NEMKO KOREA

13 Sep 2005 17:22

Conducted Emissions

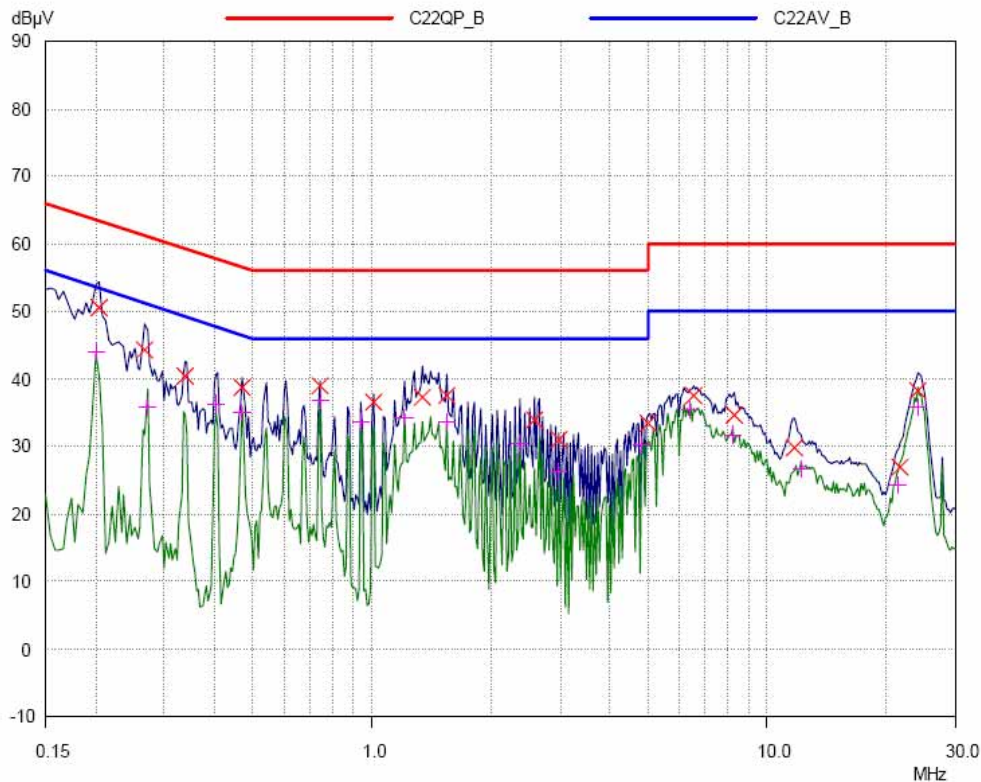
EUT: OfficeServ SOHO
 Manuf: SAMSUNG Electronics Co., Ltd.
 Op Cond: AC 120V / 60Hz (Communication Link)
 Operator:
 Test Spec: CISPR 22 Class B
 Comment: MODEL : SIT200EMRB
 LINE : LINE-PE
 Result File: e594I1.dat : OfficeServ SOHO

Scan Settings (1 Range)

Frequencies			Receiver Settings					
Start	Stop	Step	IF BW	Detector	M-Time	Atten	Preamp	OpRge
150kHz	30MHz	3.9063kHz	9kHz	PK+AV	20msec	10 dB	OFF	60dB

Transducer	No.	Start	Stop	Name
	1	150kHz	30MHz	CE_LINE

Final Measurement: Detectors: X QP / + AV
 Meas Time: 1sec
 Subranges: 16
 Acc Margin: 60 dB



PLOTS OF EMISSIONS

Conducted Emission at the Mains port (Neutral)

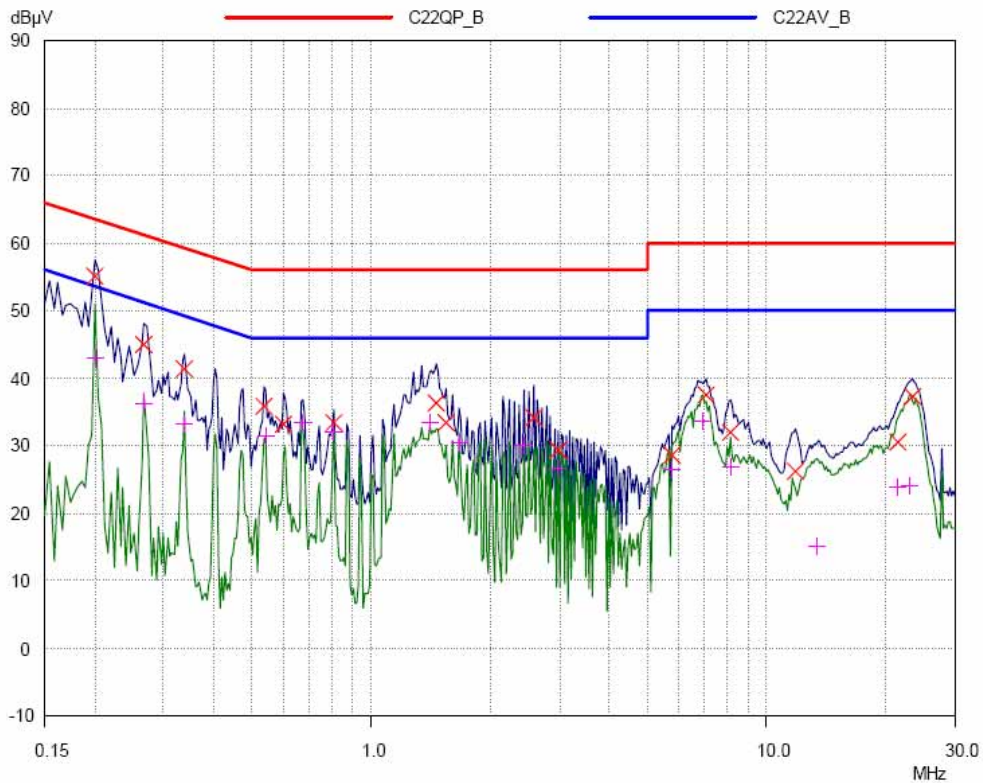
NEMKO KOREA

13 Sep 2005 17:13

Conducted Emissions

EUT: OfficeServ SOHO
 Manuf: SAMSUNG Electronics Co., Ltd.
 Op Cond: AC 120V / 60Hz (Communication Link)
 Operator:
 Test Spec: CISPR 22 Class B
 Comment: MODEL : SIT200EMRB
 LINE : NEUTRAL-PE
 Result File: e594n1.dat : OfficeServ SOHO

Scan Settings		(1 Range)			Receiver Settings				
Frequencies									
Start	Stop	Step	IF BW	Detector	M-Time	Atten	Preamp	OpRge	
150kHz	30MHz	3.9063kHz	9kHz	PK+AV	20msec	10 dB	OFF	60dB	
Transducer	No.	Start	Stop	Name					
	1	150kHz	30MHz	CE_LINE					
Final Measurement:		Detectors:	X QP / + AV						
		Meas Time:	1sec						
		Subranges:	16						
		Acc Margin:	60 dB						



TEST DATA

Radiated Emissions(general requirements) - 15.209

FCC ID : A3LWIP5001A

Test Mode:

The test data show the worst emission level from lowest channel and Middle channel and Highest channel

Frequency (MHz)	Reading (dB μ V)	Pol* (H/V)	AF+CL+Amp (dB)**	Result (dB μ V/m)	Limit (dB μ V/m)	Margin (dB)
154.15	34.3	V	-12.7	21.6	43.5	21.9
162.48	35.5	V	-12.9	22.6	43.5	20.9
196.60	39.5	V	-13.6	25.9	43.5	17.6
199.98	38.9	H	-13.7	25.2	43.5	18.3
220.81	39.5	H	-13.2	26.3	46.0	19.7
300.00	37.5	H	-11.3	26.2	46.0	19.8

Table 2. Radiated Measurements at 3meters

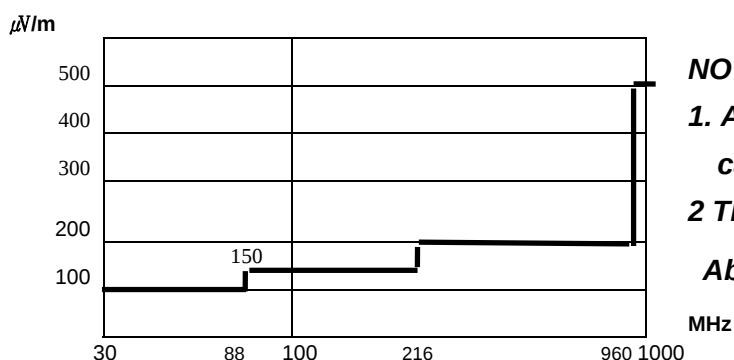


Fig. 4. Limits at 3 meters

NOTES:

1. All modes were measured and the worst-case emission was reported.

2 The radiated limits are shown on Figure 4.

Above 1GHz the limit is 500 μ V/m.

NOTES:

- *Pol. H =Horizontal V=Vertical
- **AF+CL+Amp. = Antenna Factor + Cable Loss + Amplifier.
- Measurements using CISPR quasi-peak mode.
- The limit is on the FCC Part section 15.209(a).



Tested by M. C. Shin

TEST DATA

Modulated Bandwidth (6dB Bandwidth)- 15.247(a)(2)

FCC ID : A3LWIP5001A

Test Mode : Set to Lowest channel, Middle channel and Highest channel

Result: 802.11b Mode

Channel	Frequency(MHz)	Result(KHz)	Limit(KHz)	Margin(KHz)
1	2412	11550	500	11050
6	2437	11630	500	11130
11	2462	11850	500	11350

Result: 802.11g Mode

Channel	Frequency(MHz)	Result(KHz)	Limit(KHz)	Margin(KHz)
1	2412	16250	500	15750
6	2437	15750	500	15250
11	2462	16250	500	15750

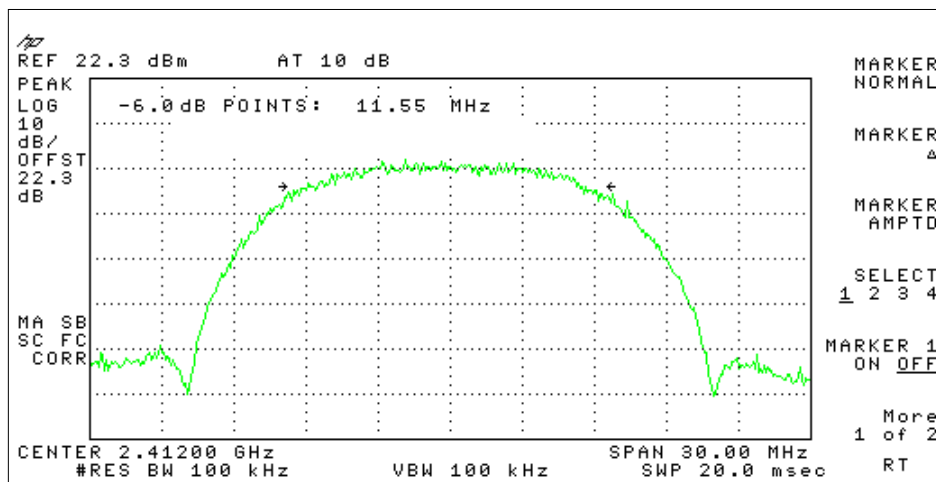


Tested by **M. C.Shin**

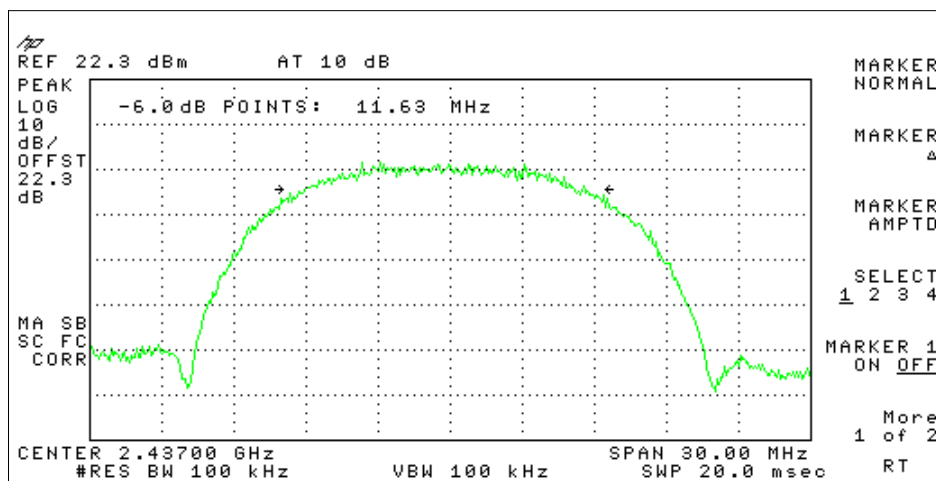
PLOTS OF EMISSIONS

- 802.11b mode -

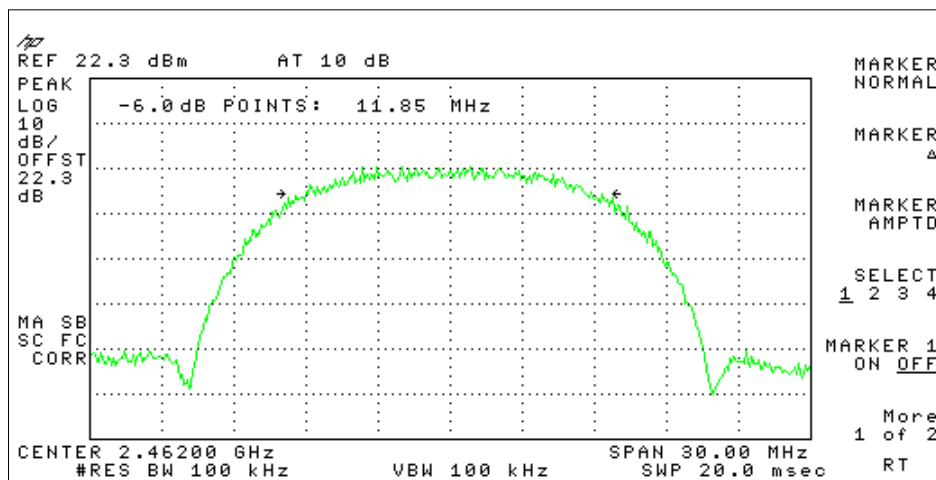
6dB Bandwidth, Lowest Channel (2412MHz)



6dB Bandwidth, Middle Channel (2437MHz)



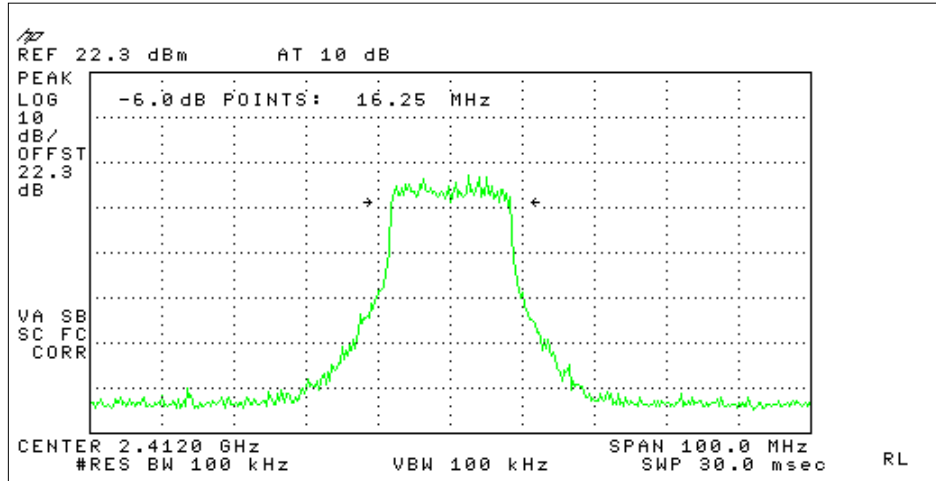
6dB Bandwidth, Highest Channel (2462MHz)



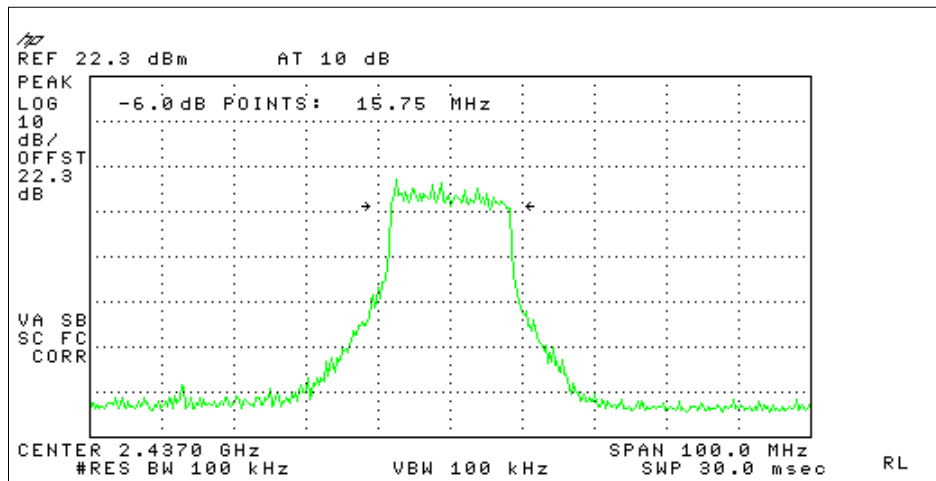
PLOTS OF EMISSIONS

- 802.11g mode -

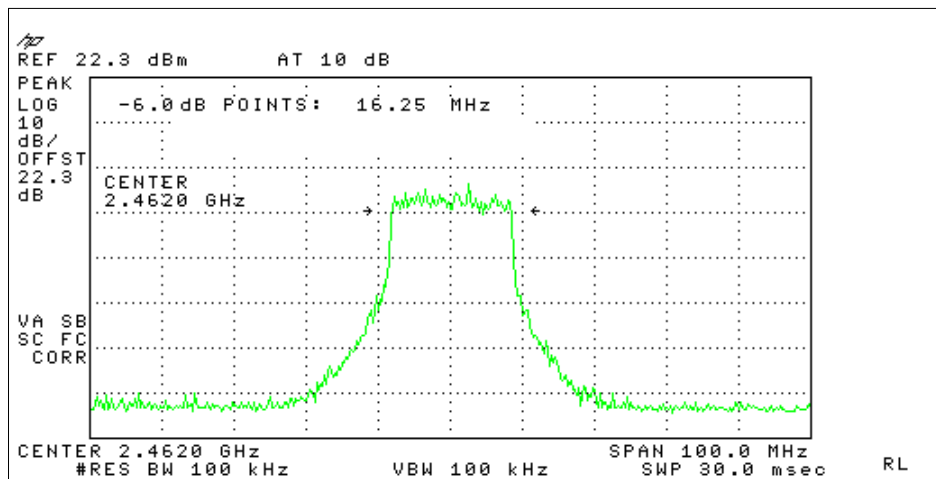
6dB Bandwidth, Lowest Channel (2412MHz)



6dB Bandwidth, Middle Channel (2437MHz)



6dB Bandwidth, Highest Channel (2462MHz)



TEST DATA

Peak Power Output – 15.247(b)

FCC ID : A3LWIP5001A

Test Mode : Set to Lowest channel, Middle channel and Highest channel

- 802.11b mode -

Channel	Frequency(MHz)	Result(dBm)	Limit(dBm)	Margin(dB)
1	2412	16.02	30	-13.98
6	2437	15.84	30	-14.16
11	2462	15.62	30	-14.38

- 802.11g mode -

Channel	Frequency(MHz)	Result(dBm)	Limit(dBm)	Margin(dB)
1	2412	16.34	30	-13.66
6	2437	16.17	30	-13.83
11	2462	16.01	30	-13.99



Tested by **M. C. Shin**

TEST DATA

Conducted Spurious Emission – 15.247(c)

FCC ID : A3LWIP5001A

Test Mode : Set to Lowest channel, Middle channel and Highest channel

- 802.11b, 802.11g mode -

Channel	Frequency(MHz)	Result(dBc)	Limit(dBc)	Margin(dB)
1	2412	More than 40dBc	20	
6	2437	More than 40dBc	20	
11	2462	More than 40dBc	20	

Radiated Spurious Emission – 15.247(c)

FCC ID : A3LWIP5001A

Test Mode : Set to Lowest channel, Middle channel and Highest channel

- 802.11b, 802.11g mode -

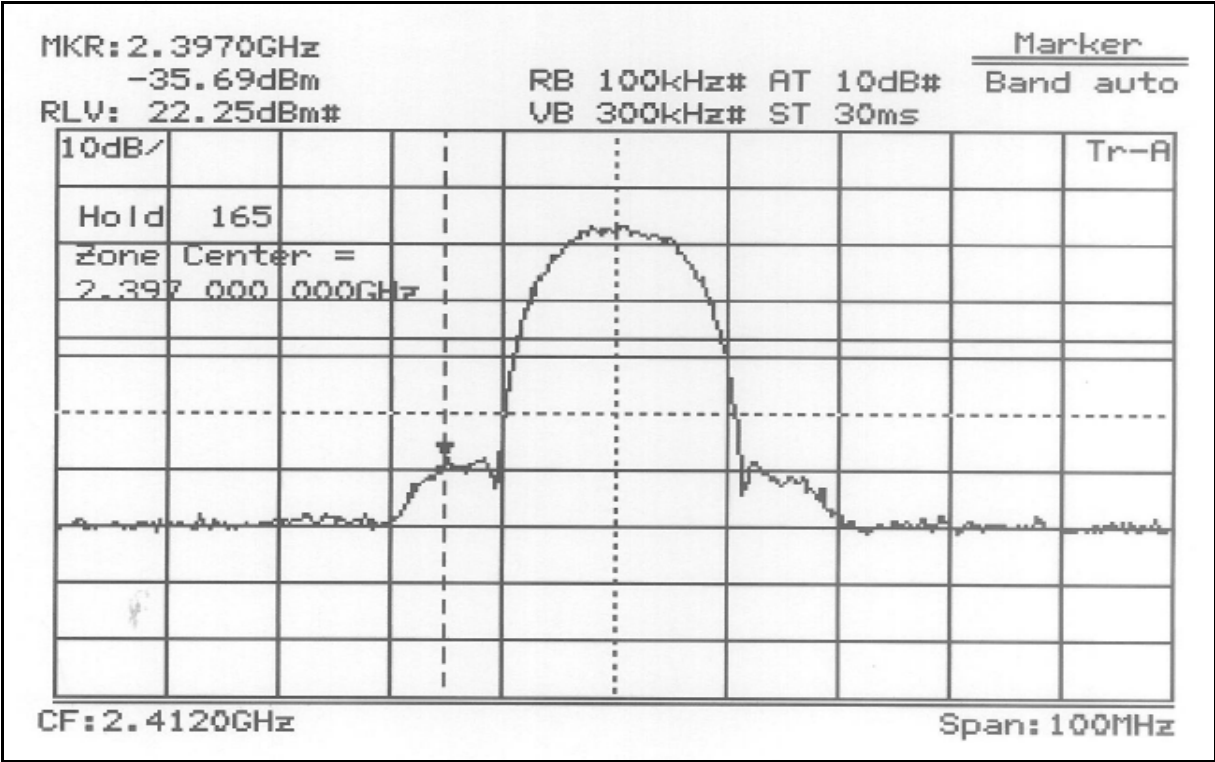
Channel	Frequency (MHz)	Pol (H/V)	Result (dBuV)	Limit (dBc)	Margin (dB)
1	2412	H	Under 20dB below Fundamental	20	
1	2412	V	Under 20dB below Fundamental	20	
6	2437	H	Under 20dB below Fundamental	20	
6	2437	V	Under 20dB below Fundamental	20	
11	2462	H	Under 20dB below Fundamental	20	
11	2462	V	Under 20dB below Fundamental	20	



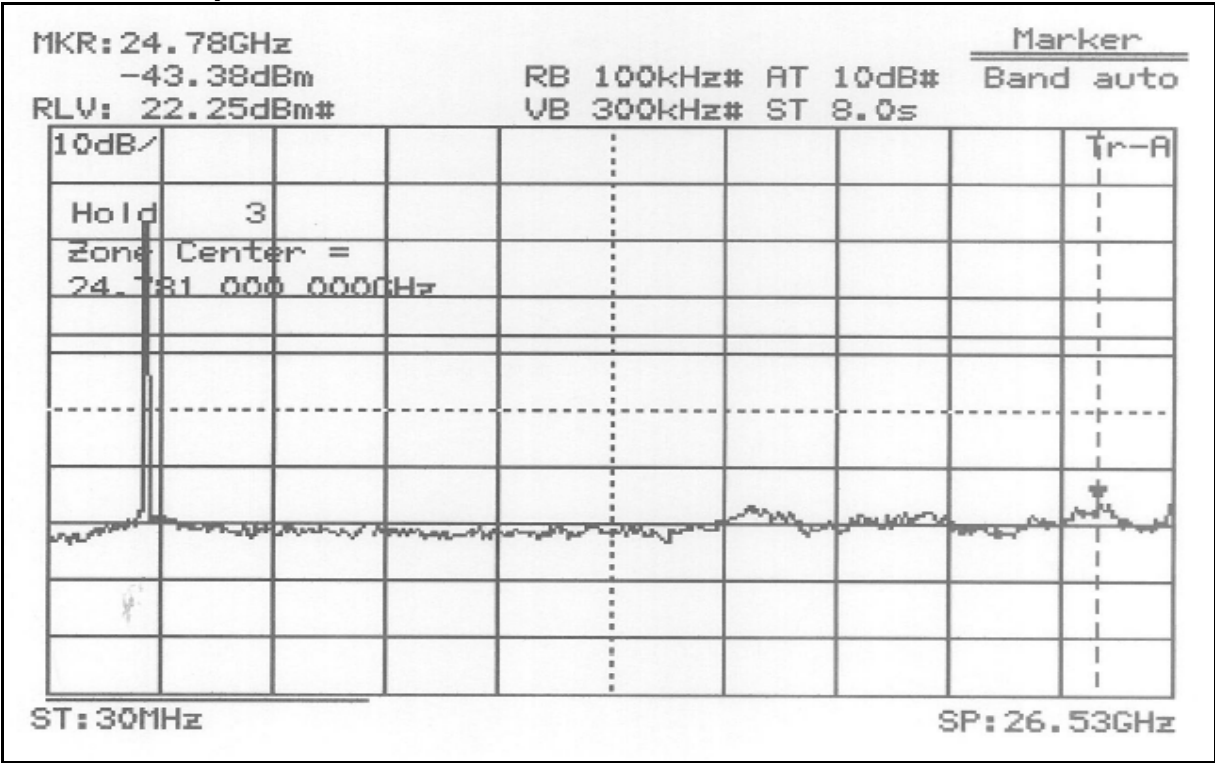
Tested by M. C. Shin

PLOT OF TEST DATA

Band edge at 2.4GHz, Lowest Channel

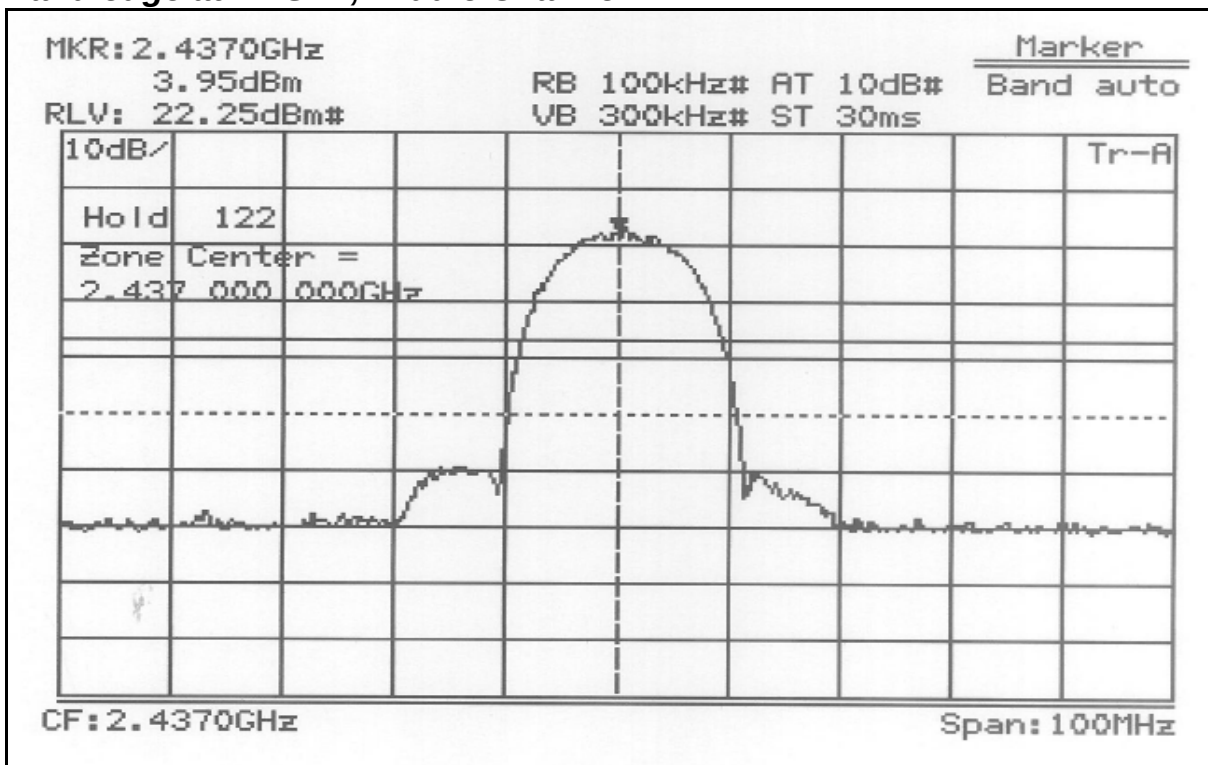


Conducted Spurious Emissions, Lowest Channel

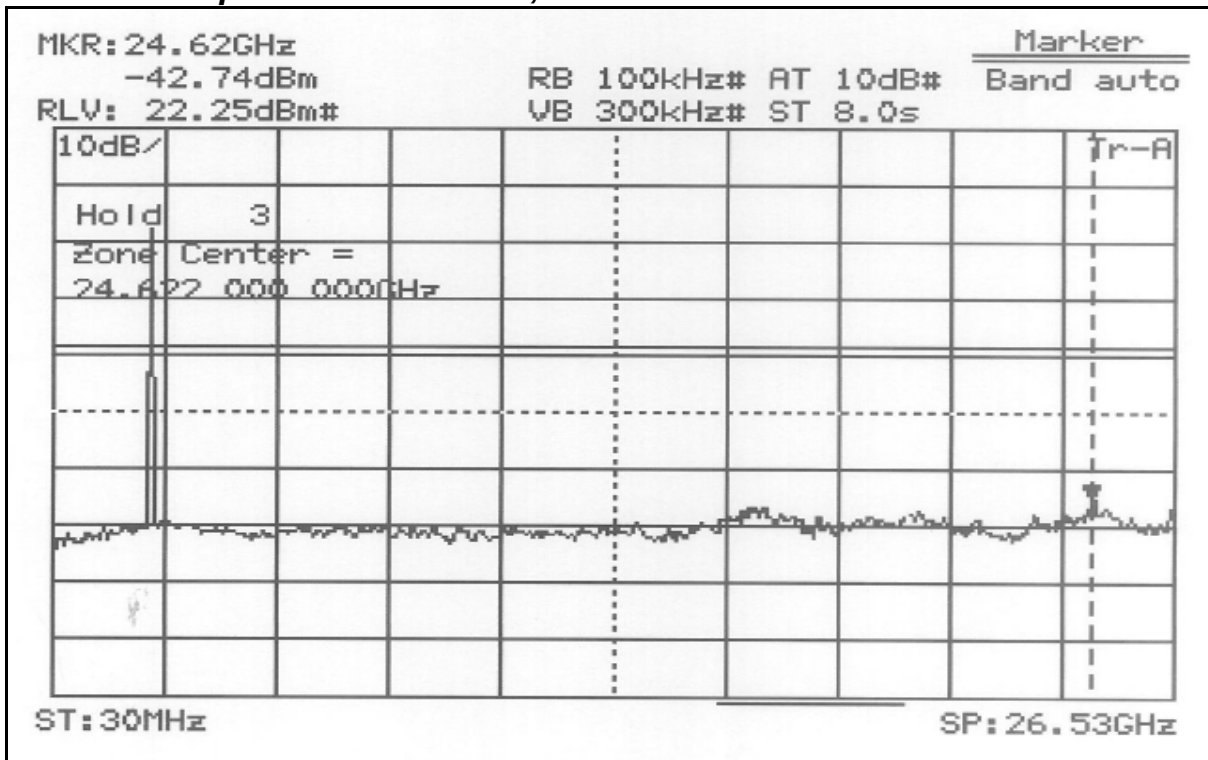


PLOT OF TEST DATA

Band edge at 2.4GHz, Middle Channel

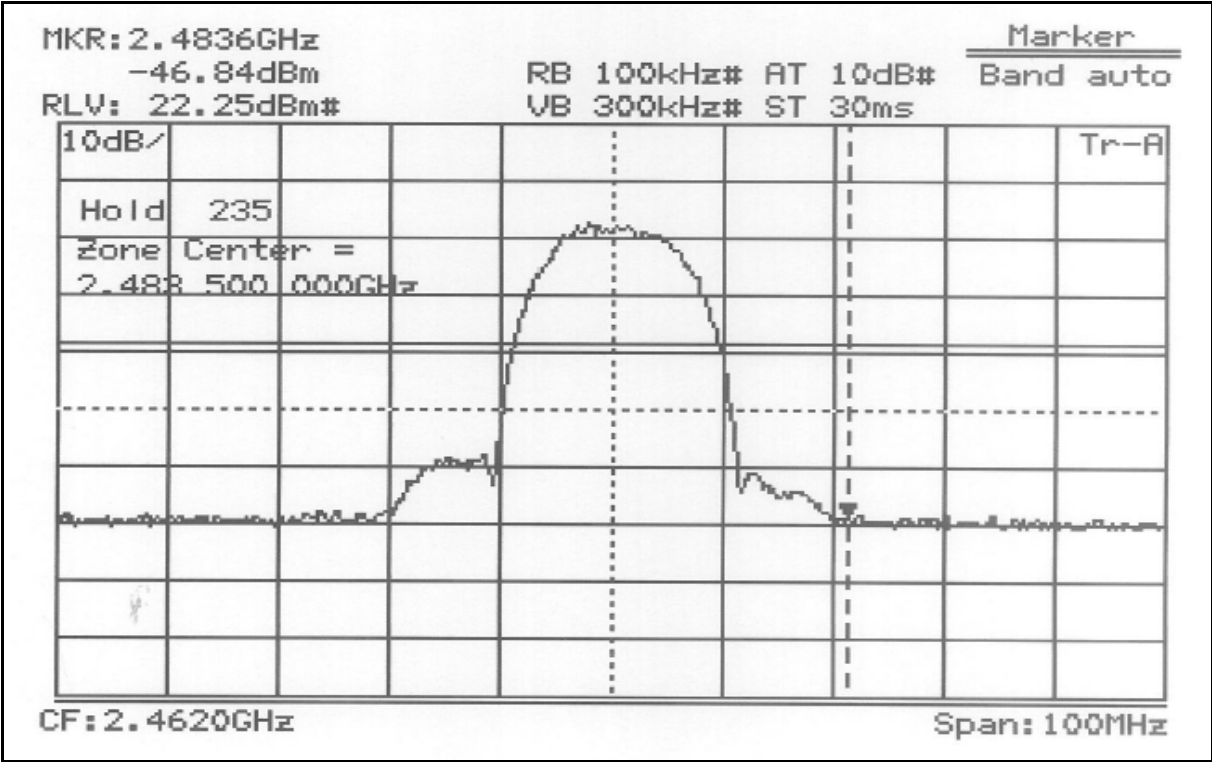


Conducted Spurious Emissions, Middle channel

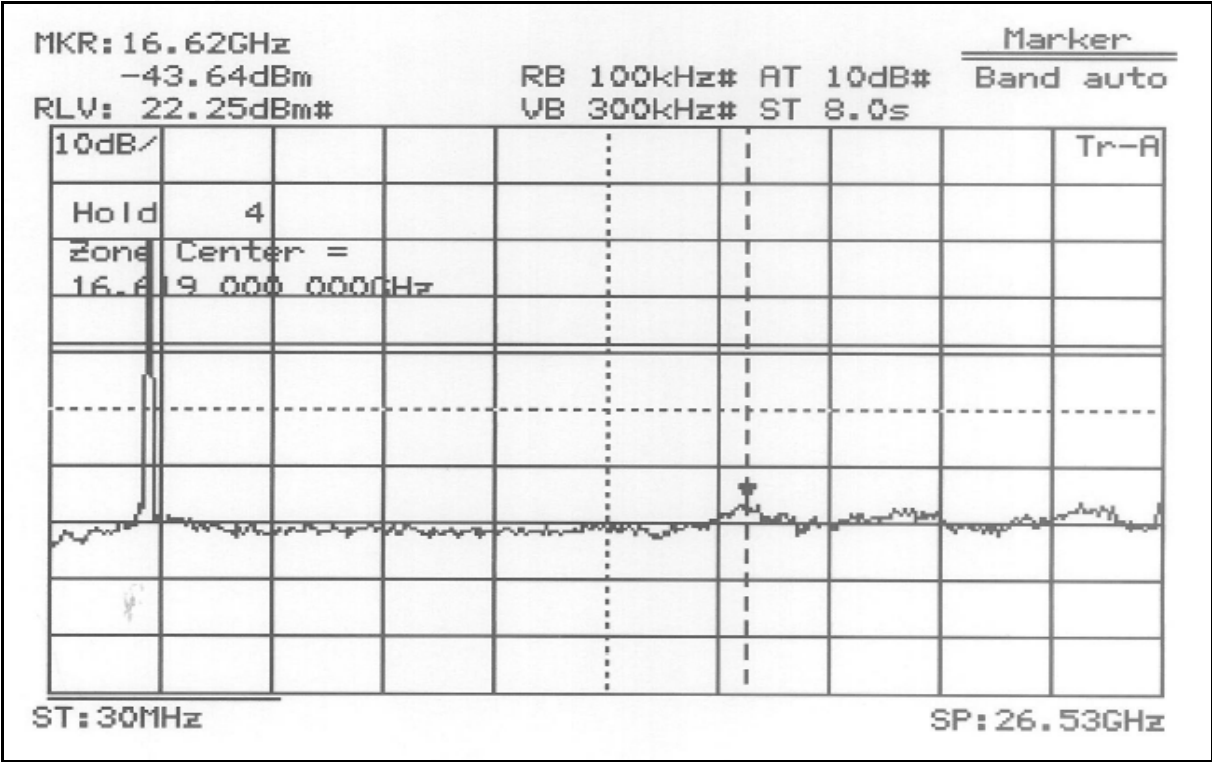


PLOT OF TEST DATA

Band edge at 2.4GHz, Highest Channel



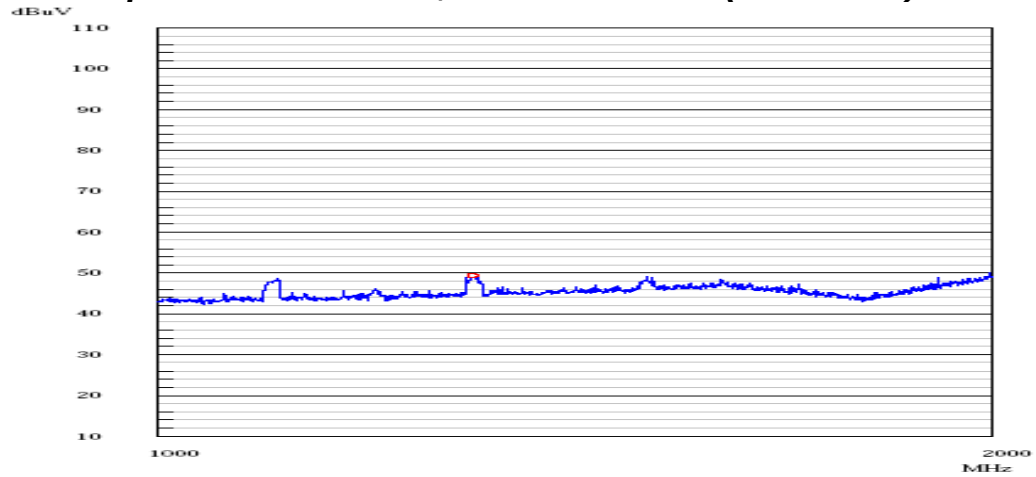
Conducted Spurious Emissions, Highest Channel



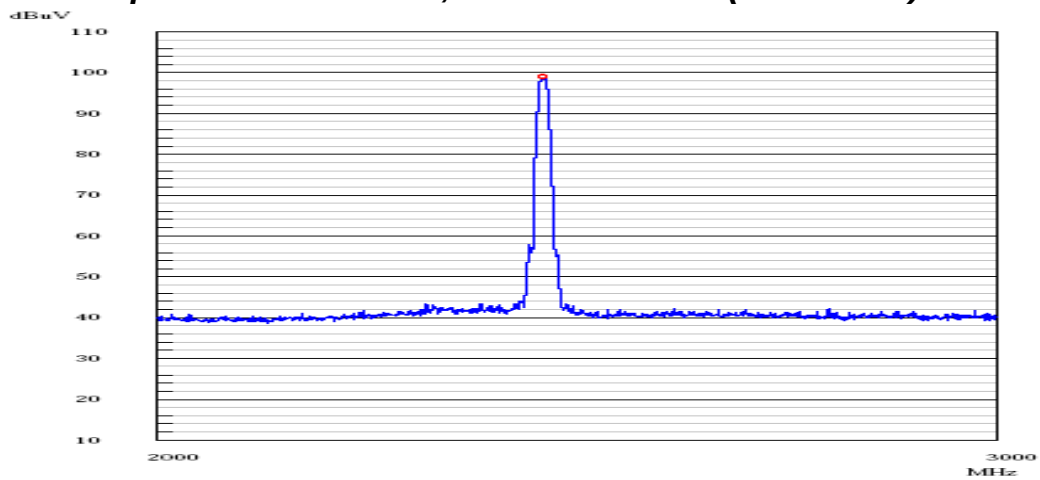
PLOT OF TEST DATA

- 802.11b -

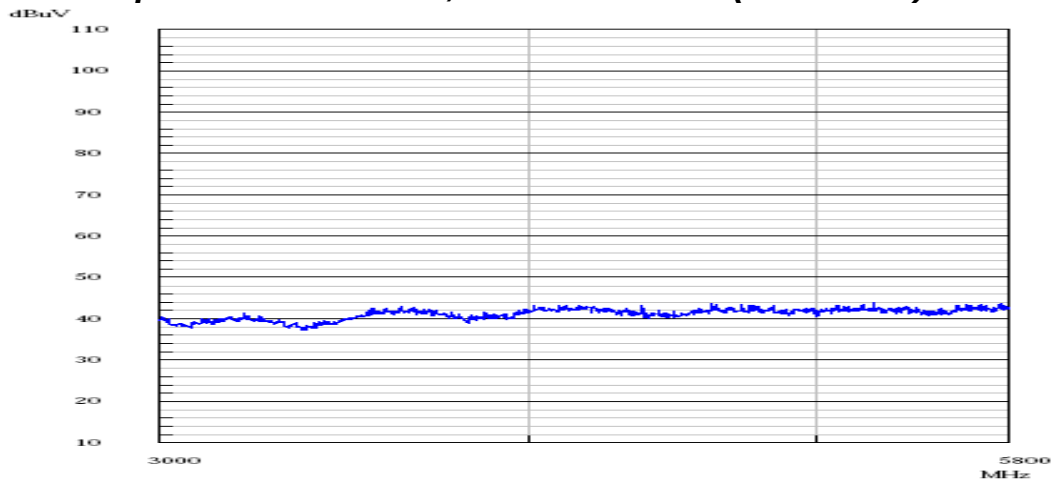
Radiated Spurious Emissions, Lowest Channel(Horizontal)



Radiated Spurious Emissions, Lowest Channel(Horizontal)

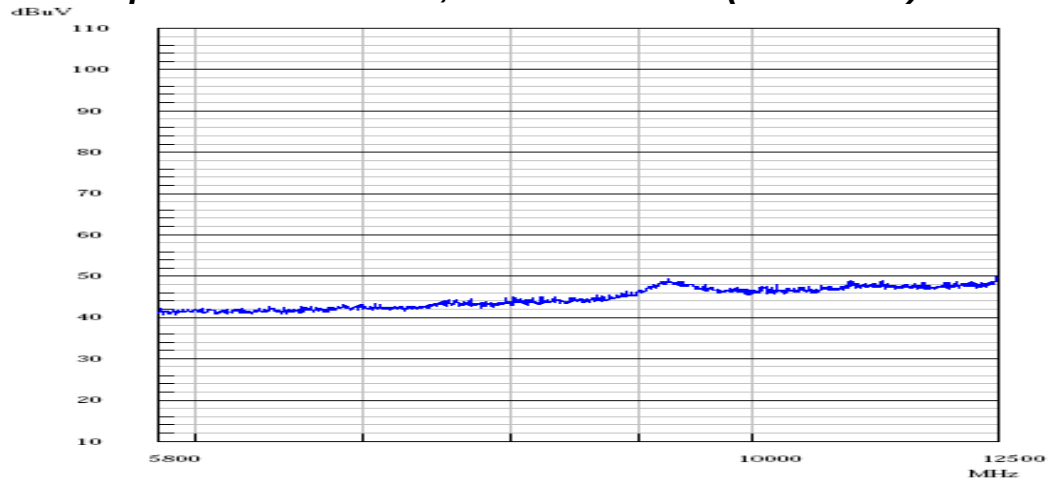


Radiated Spurious Emissions, Lowest Channel(Horizontal)

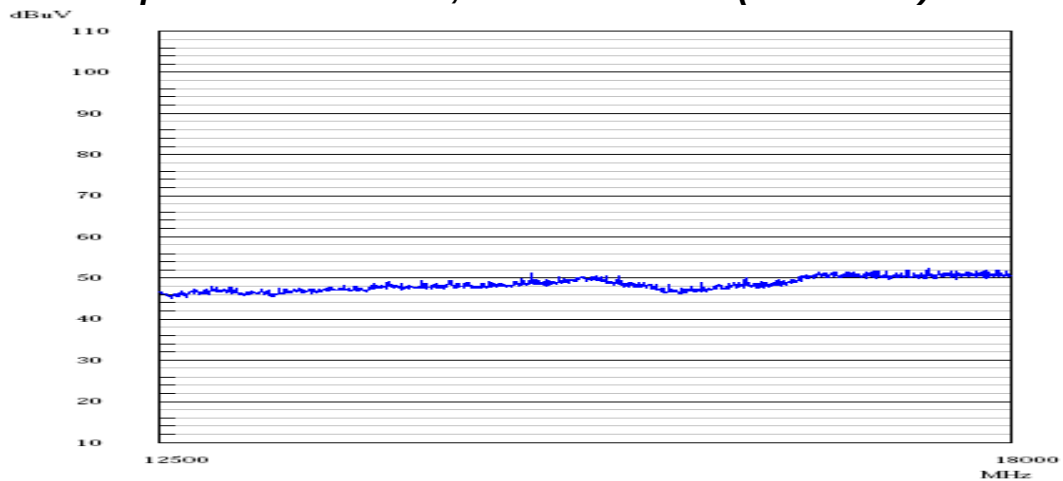


PLOT OF TEST DATA

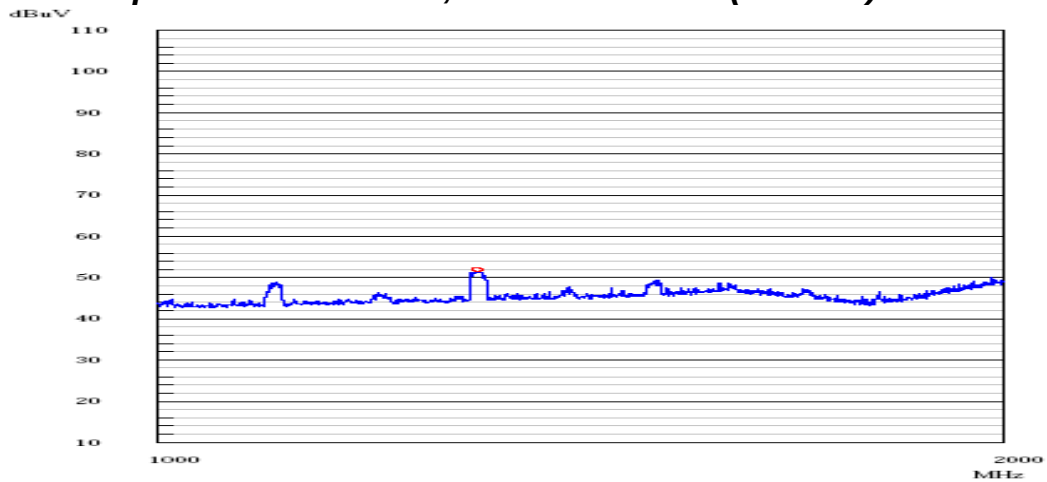
Radiated Spurious Emissions, Lowest Channel(Horizontal)



Radiated Spurious Emissions, Lowest Channel(Horizontal)

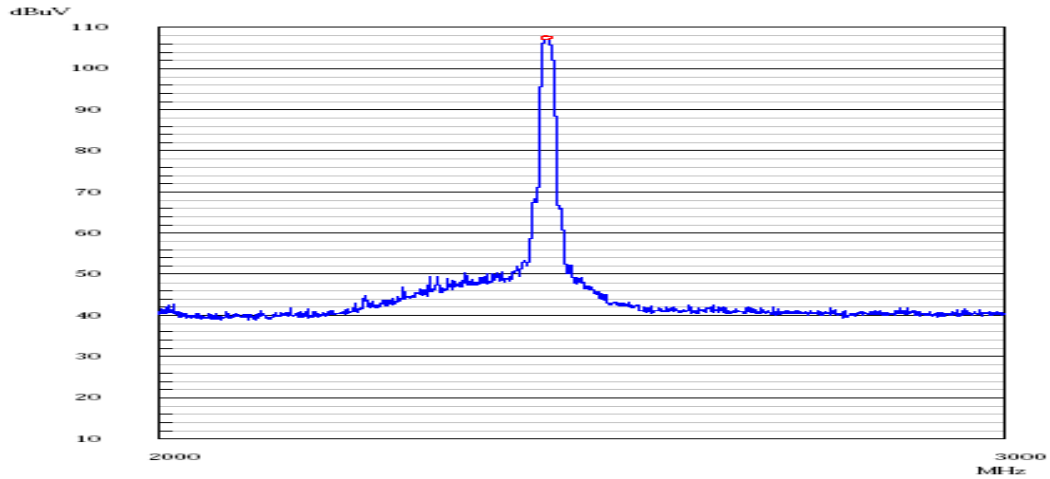


Radiated Spurious Emissions, Lowest Channel(Vertical)

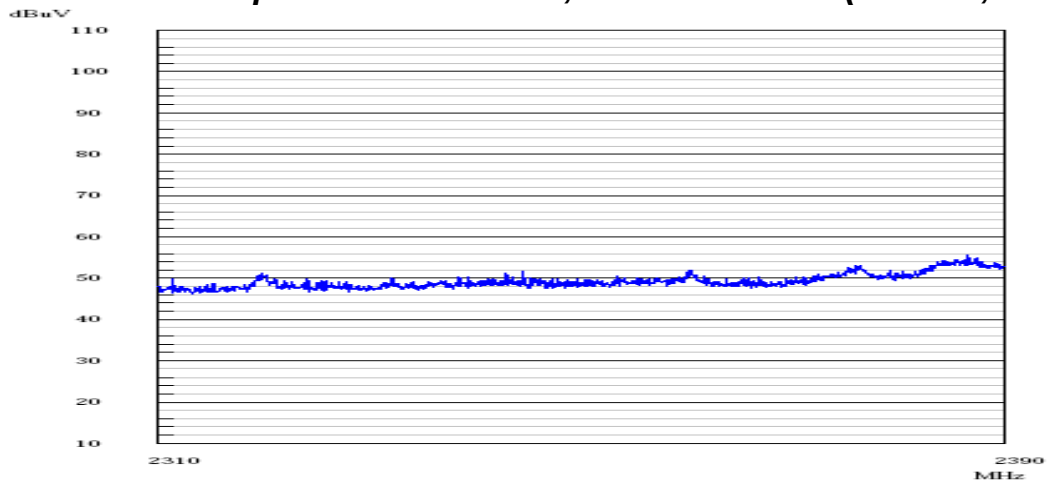


PLOT OF TEST DATA

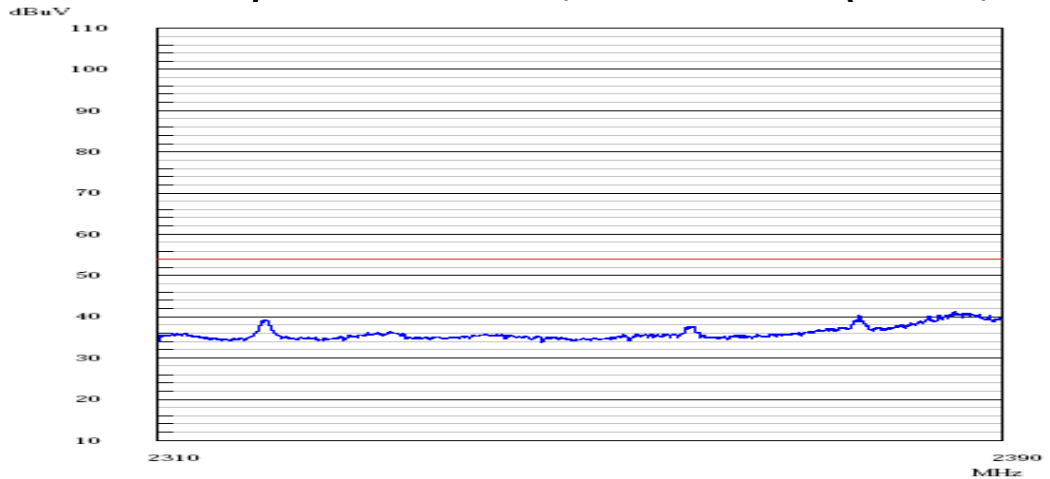
Radiated Spurious Emissions, Lowest Channel(Vertical)



Restricted Band Spurious Emissions, Lowest channel(Vertical, Peak)

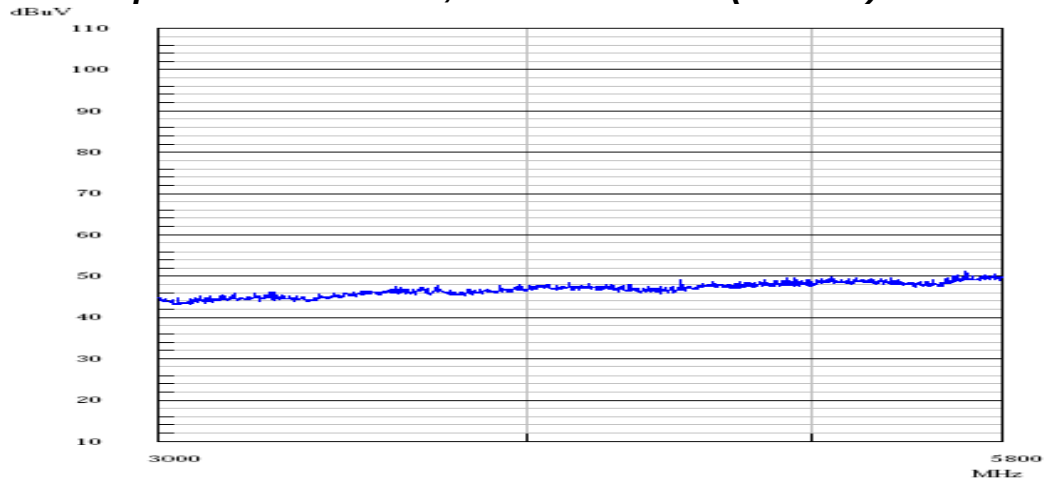


Restricted Band Spurious Emissions, Lowest channel(Vertical, Average)

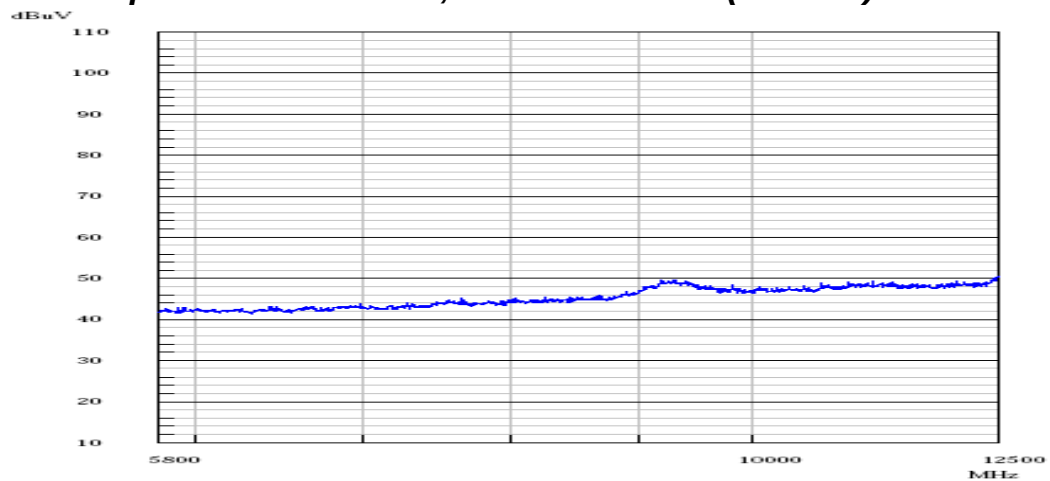


PLOT OF TEST DATA

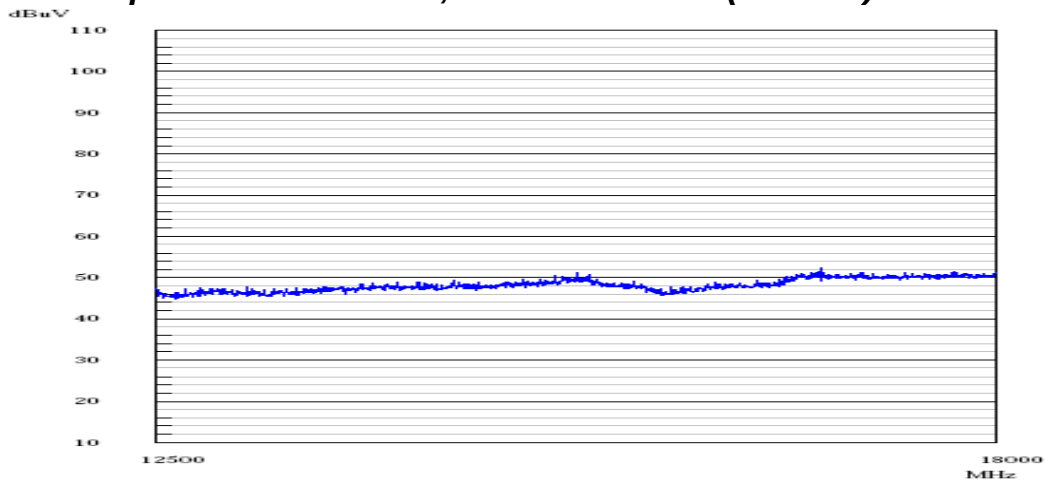
Radiated Spurious Emissions, Lowest Channel(Vertical)



Radiated Spurious Emissions, Lowest Channel(Vertical)

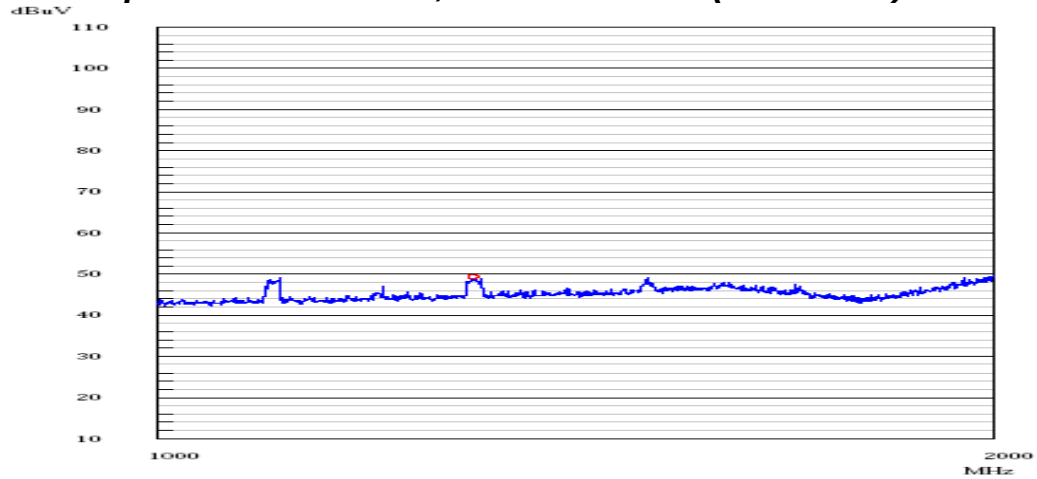


Radiated Spurious Emissions, Lowest Channel(Vertical)

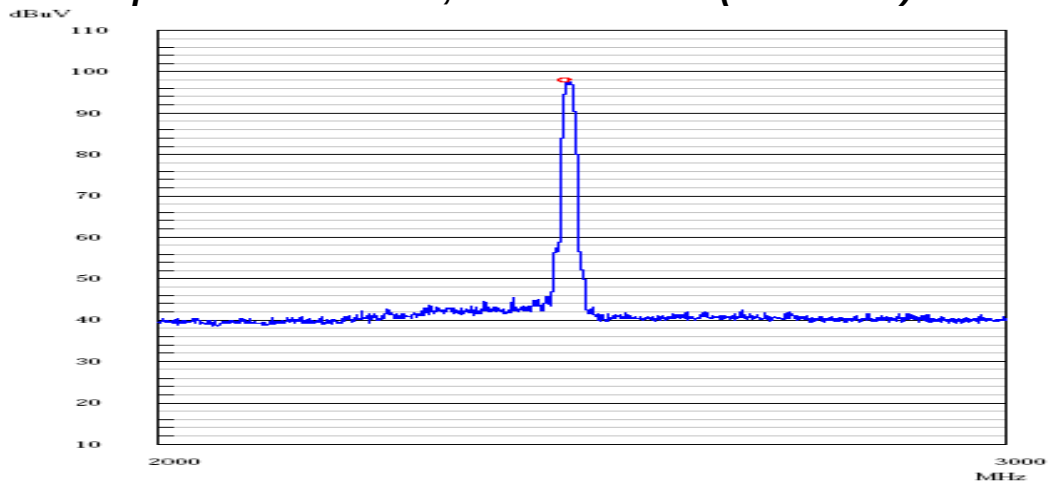


PLOT OF TEST DATA

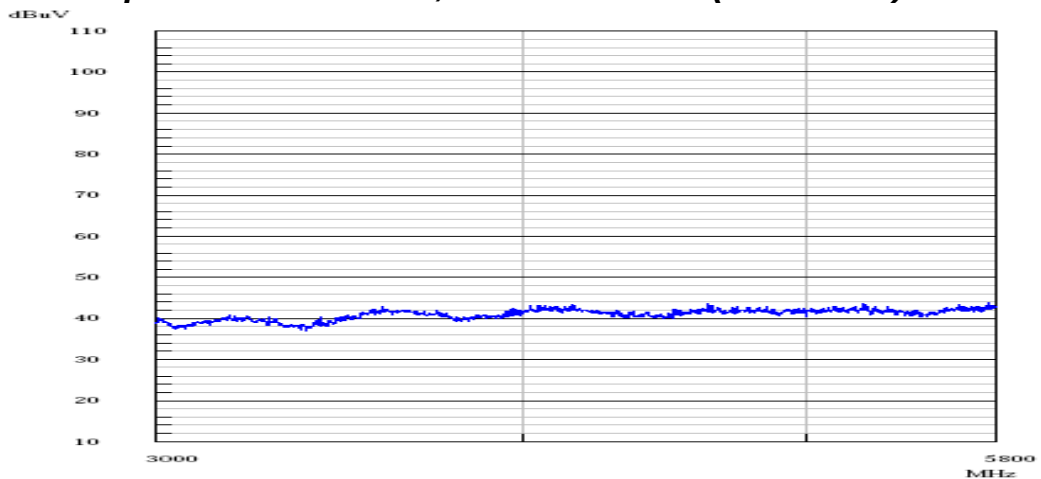
Radiated Spurious Emissions, Middle Channel(Horizontal)



Radiated Spurious Emissions, Middle Channel(Horizontal)

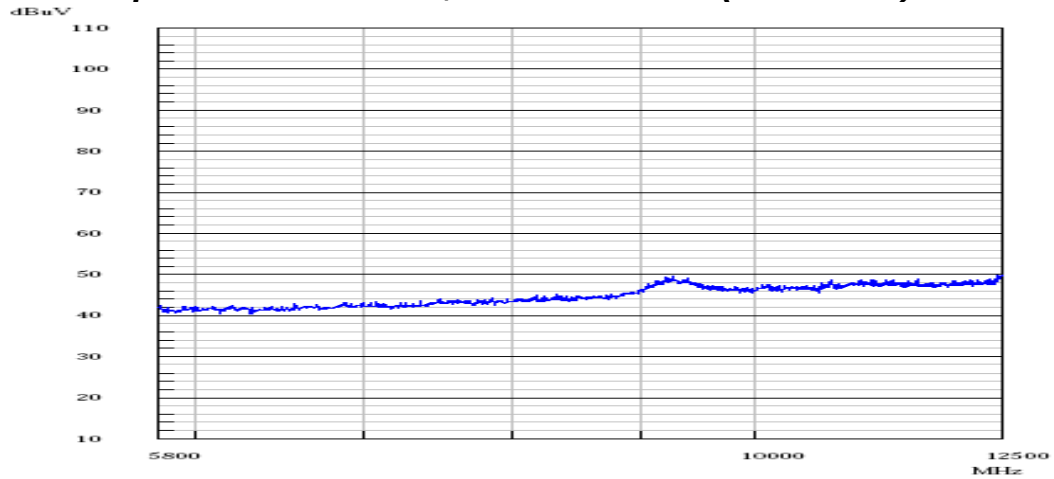


Radiated Spurious Emissions, Middle Channel(Horizontal)

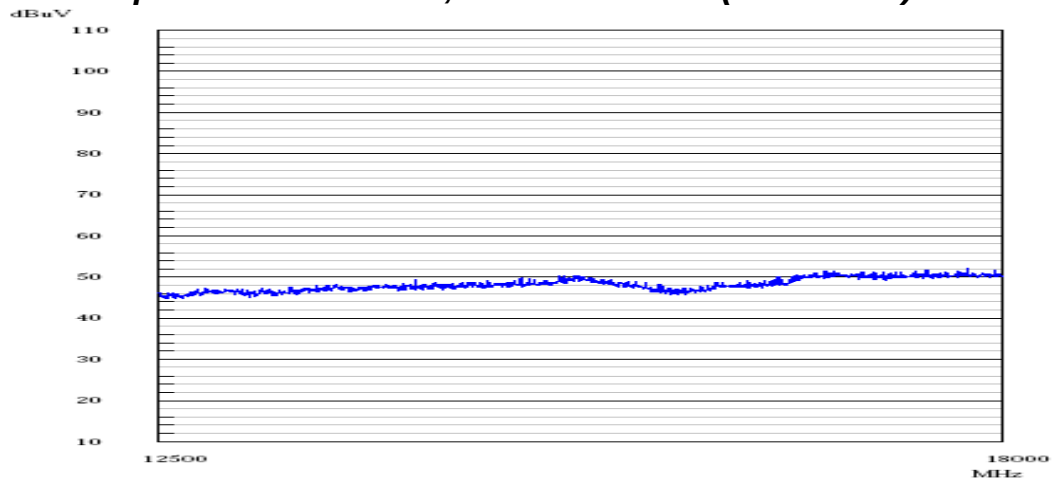


PLOT OF TEST DATA

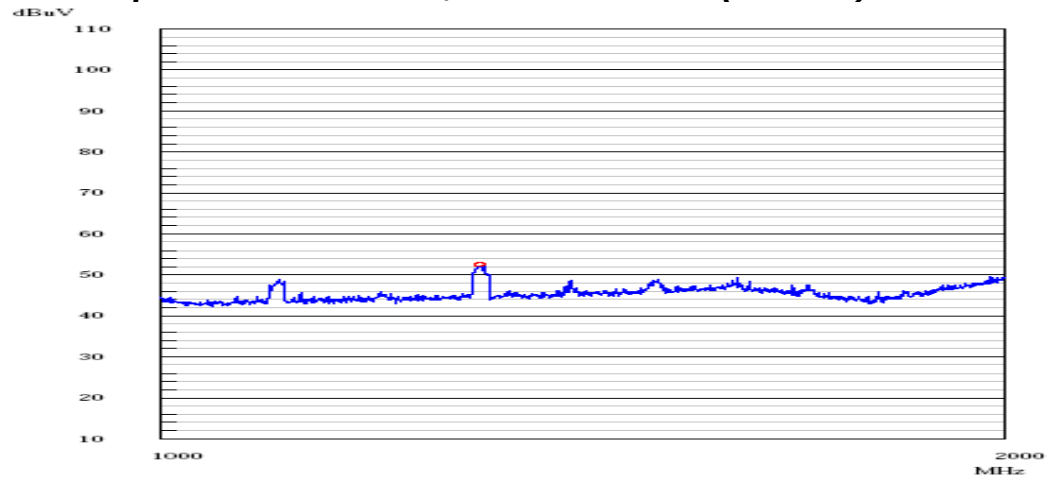
Radiated Spurious Emissions, Middle Channel(Horizontal)



Radiated Spurious Emissions, Middle Channel(Horizontal)

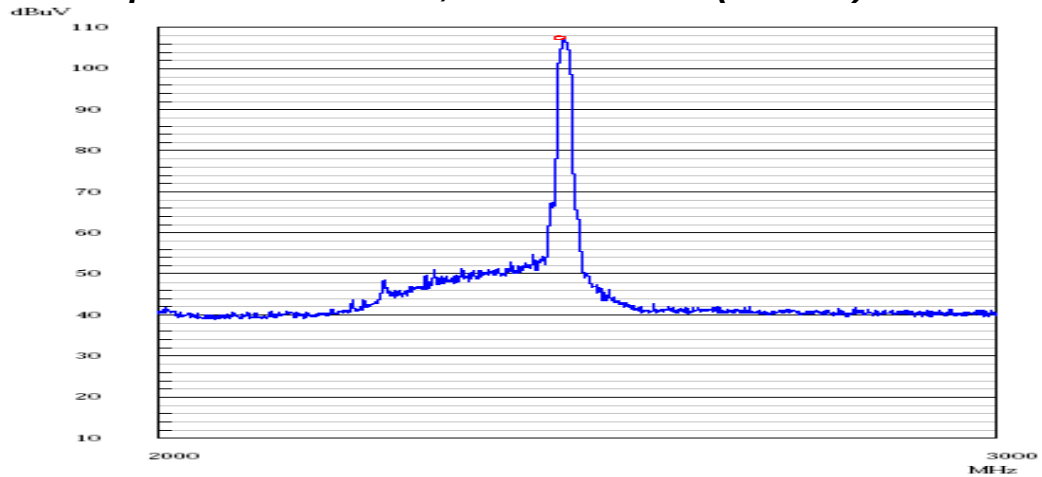


Radiated Spurious Emissions, Middle Channel(Vertical)

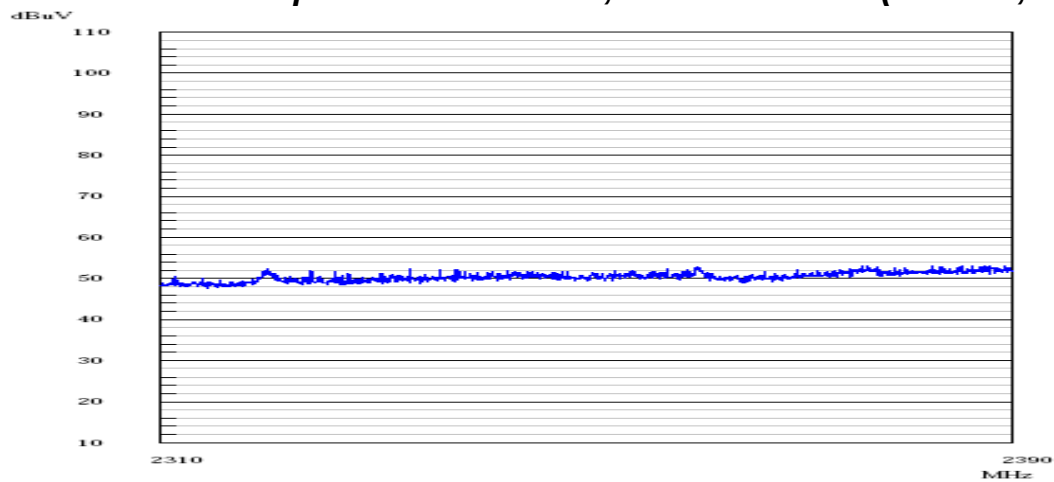


PLOT OF TEST DATA

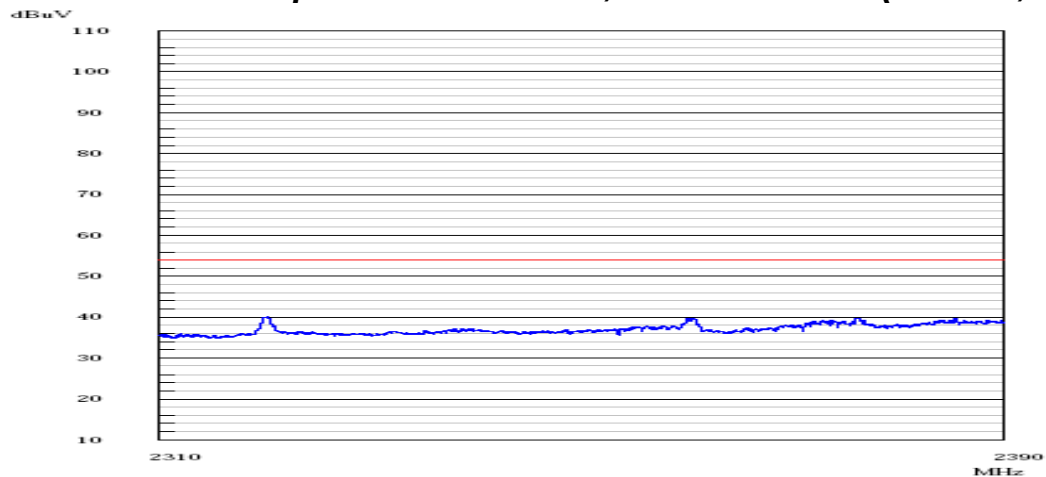
Radiated Spurious Emissions, Middle Channel(Vertical)



Restricted Band Spurious Emissions, Middle Channel(Vertical, Peak)

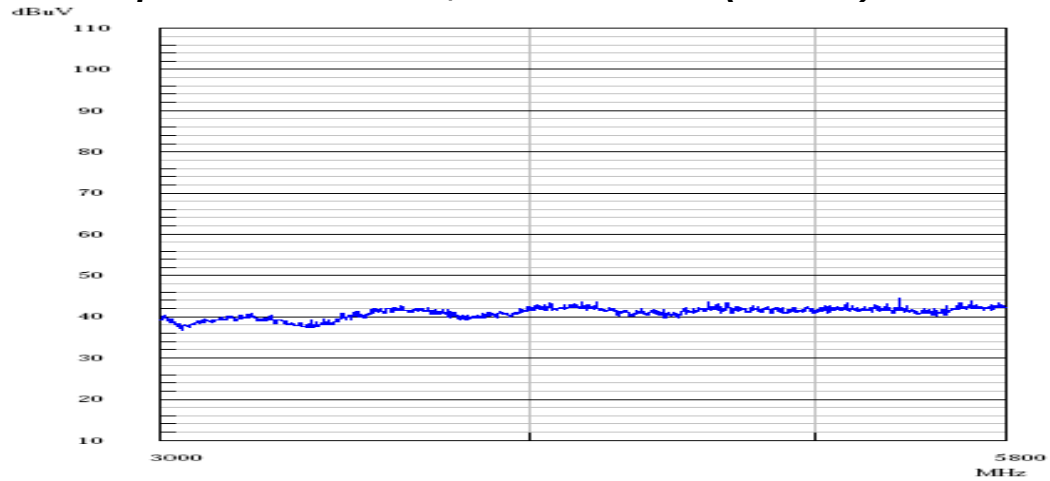


Restricted Band Spurious Emissions, Middle Channel(Vertical, Average)

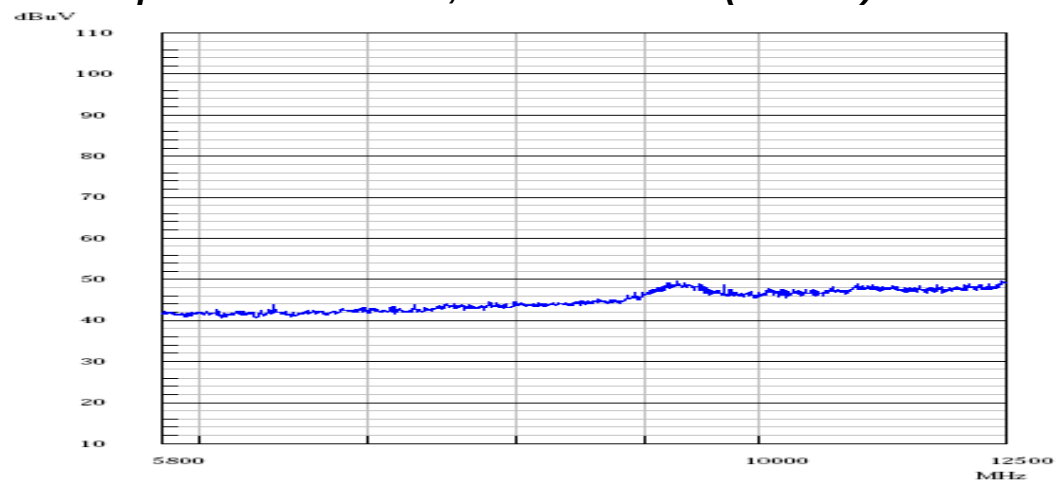


PLOT OF TEST DATA

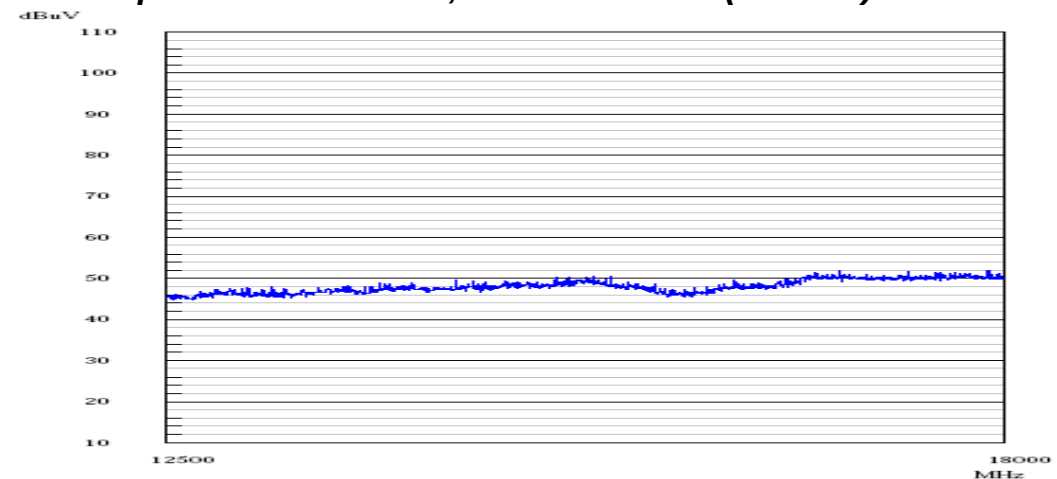
Radiated Spurious Emissions, Middle Channel(Vertical)



Radiated Spurious Emissions, Middle Channel(Vertical)

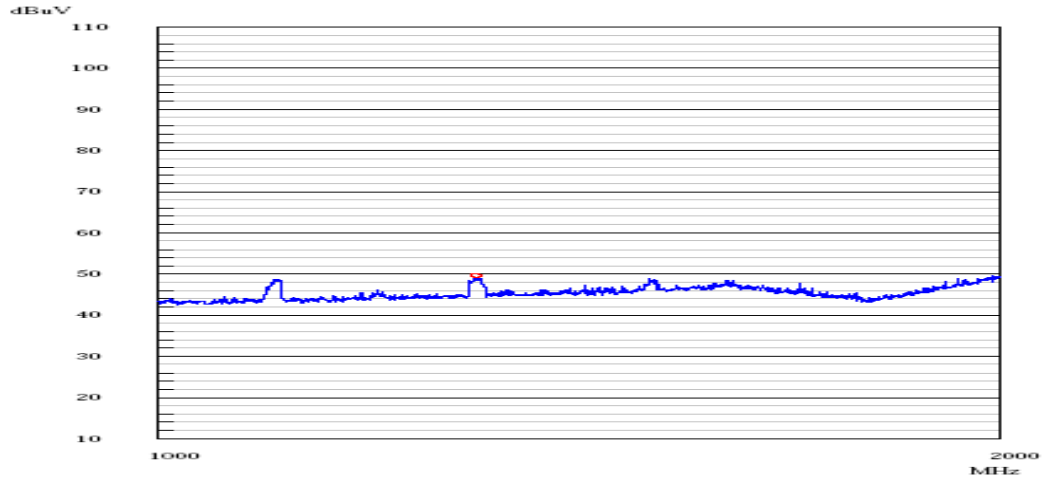


Radiated Spurious Emissions, Middle Channel(Vertical)

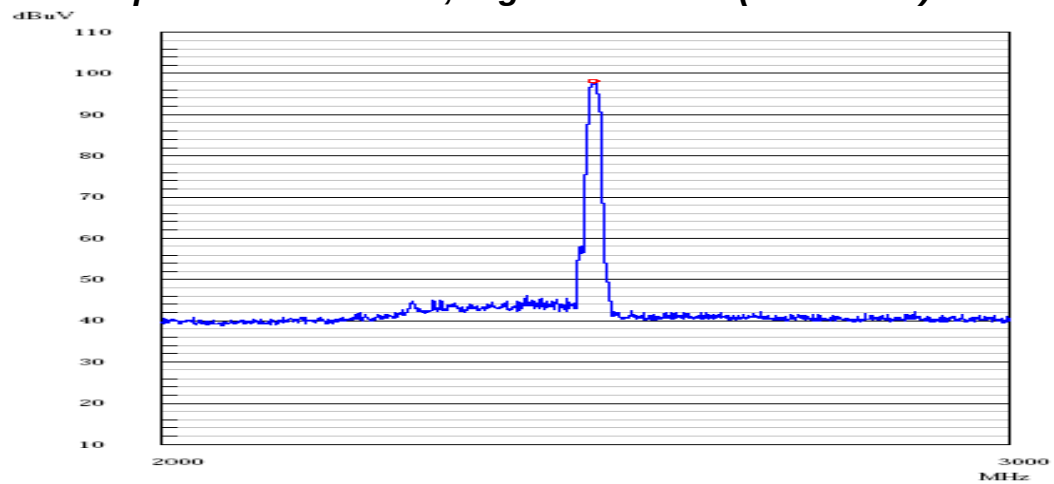


PLOT OF TEST DATA

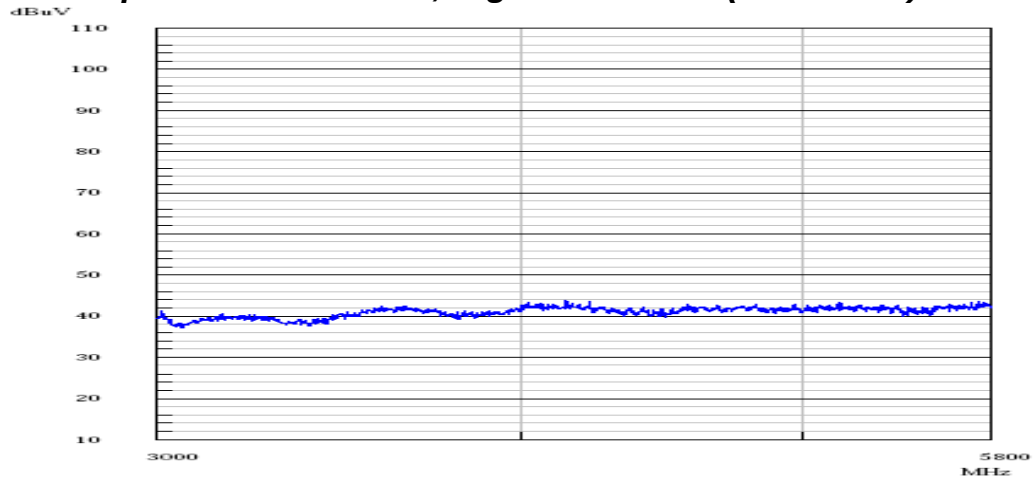
Radiated Spurious Emissions, Highest Channel(Horizontal)



Radiated Spurious Emissions, Highest Channel(Horizontal)

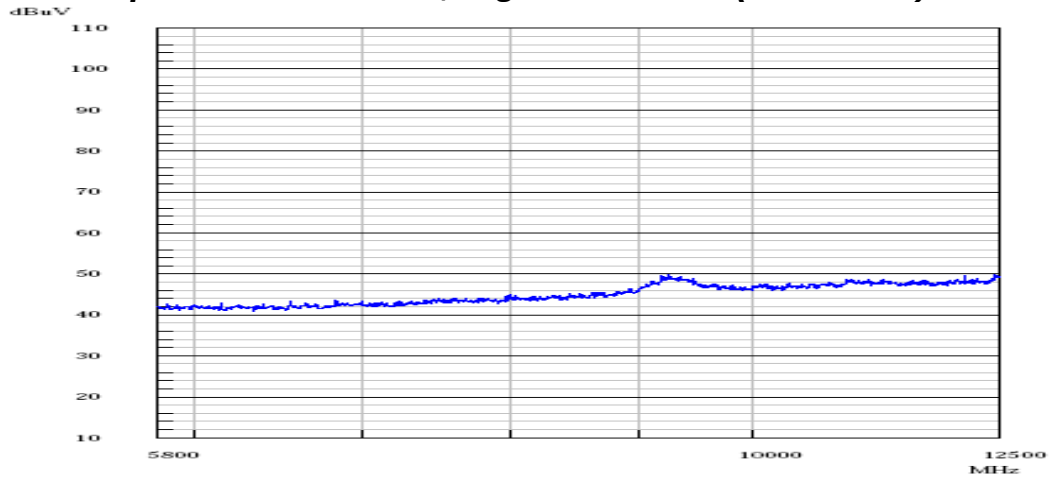


Radiated Spurious Emissions, Highest Channel(Horizontal)

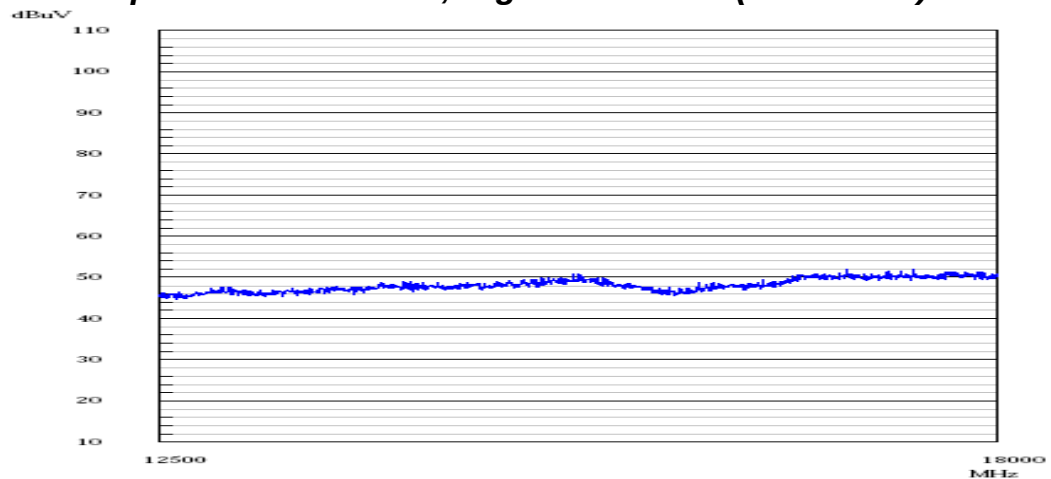


PLOT OF TEST DATA

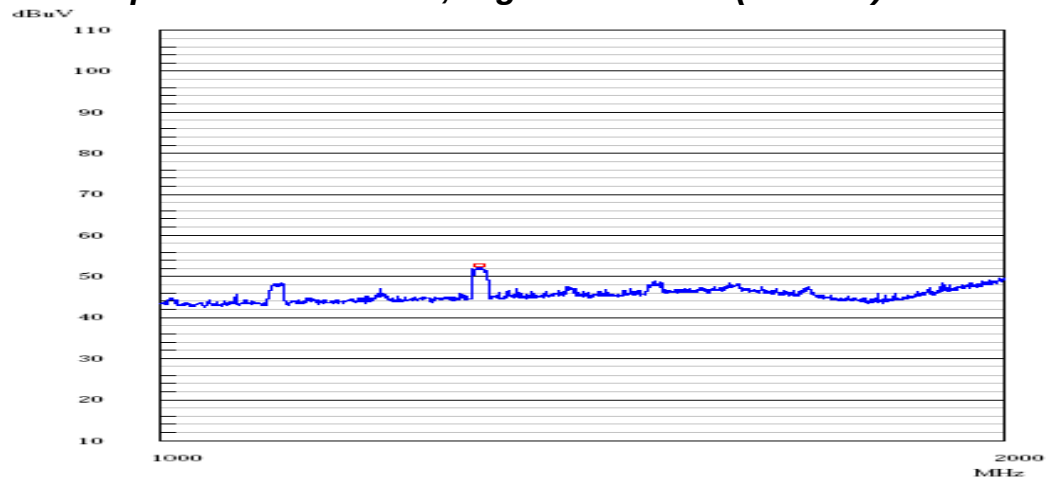
Radiated Spurious Emissions, Highest Channel(Horizontal)



Radiated Spurious Emissions, Highest Channel(Horizontal)

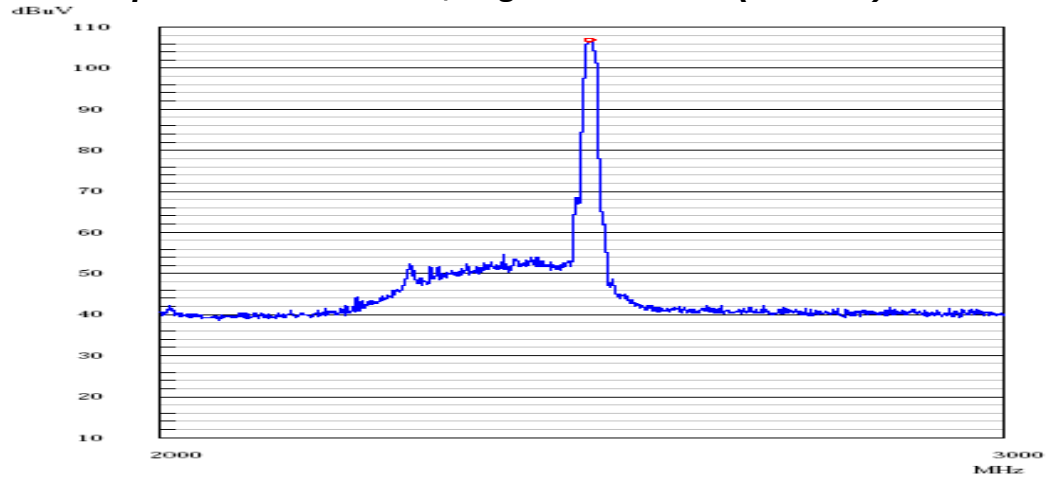


Radiated Spurious Emissions, Highest Channel(Vertical)

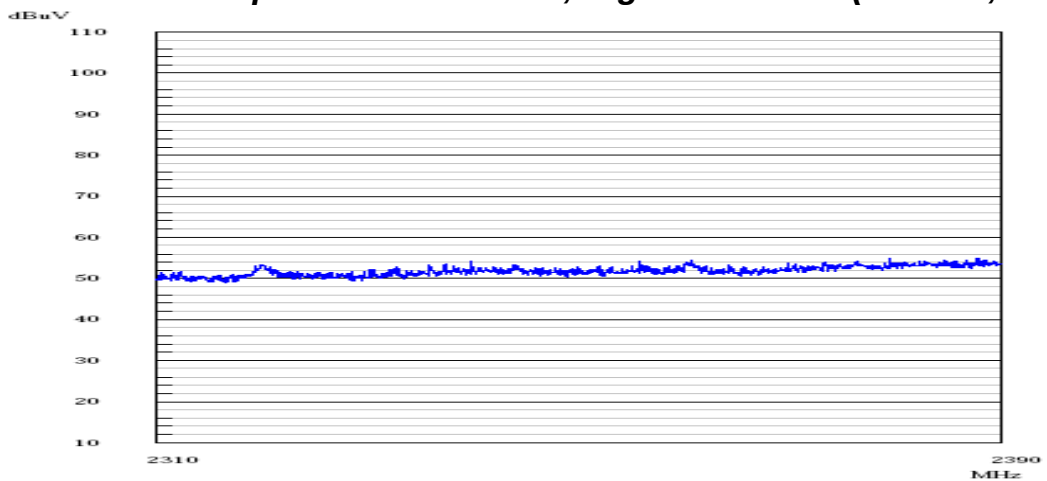


PLOT OF TEST DATA

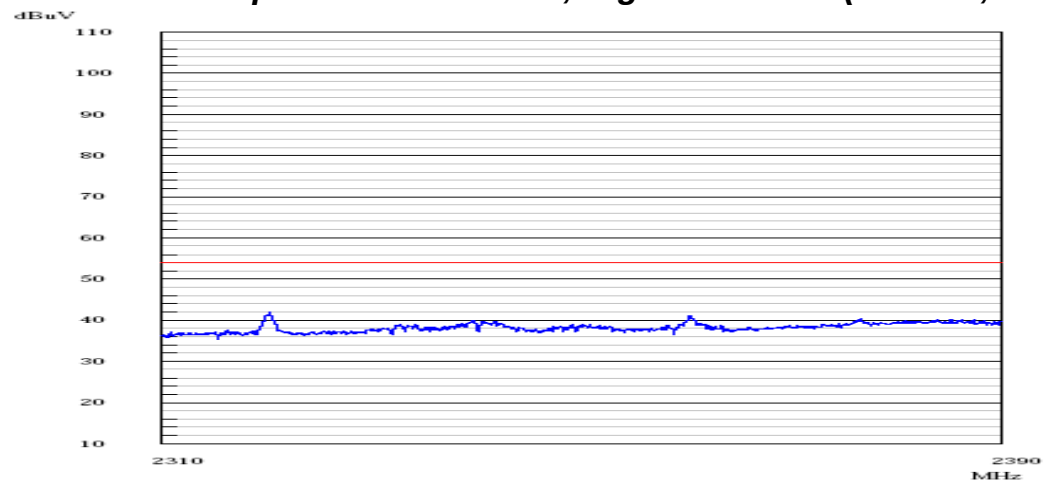
Radiated Spurious Emissions, Highest Channel(Vertical)



Restricted Band Spurious Emissions, Highest channel(Vertical, Peak)

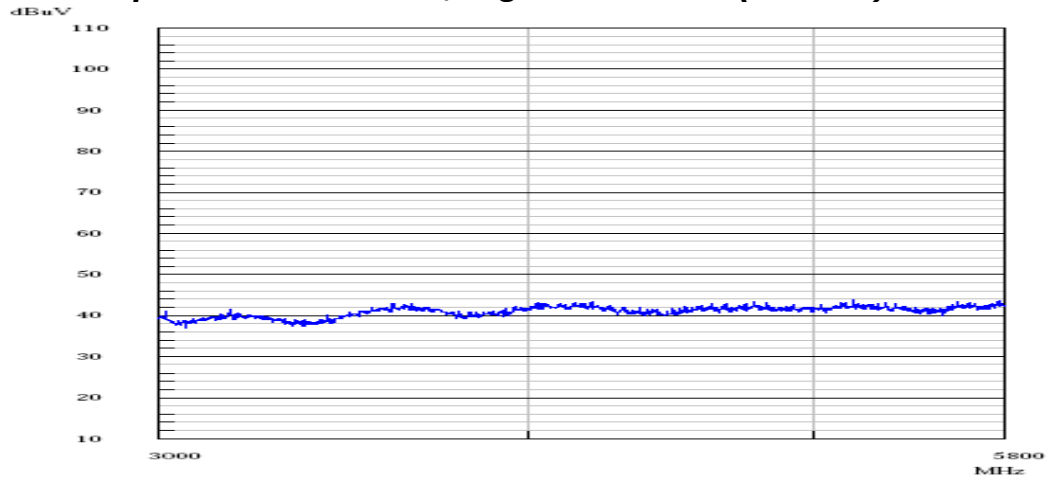


Restricted Band Spurious Emissions, Hightst channel(Vertical, Average)

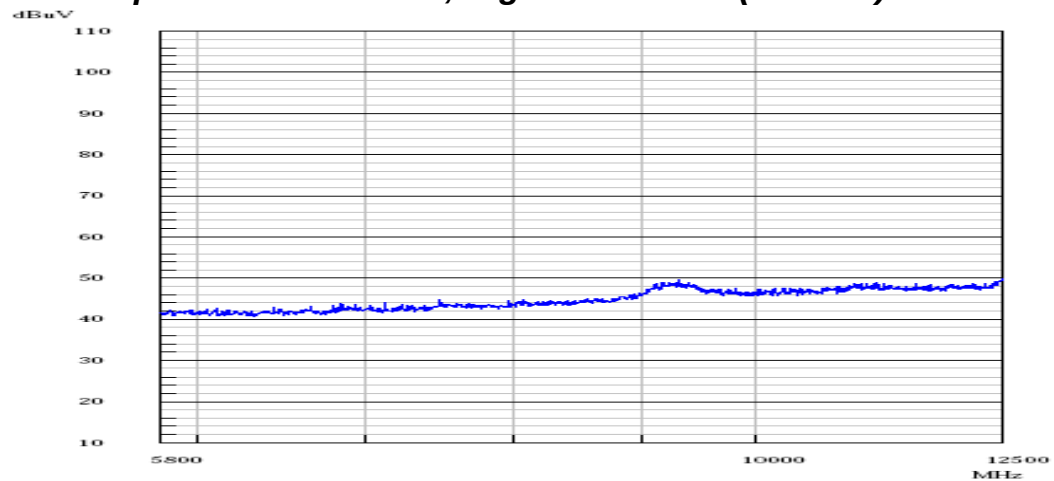


PLOT OF TEST DATA

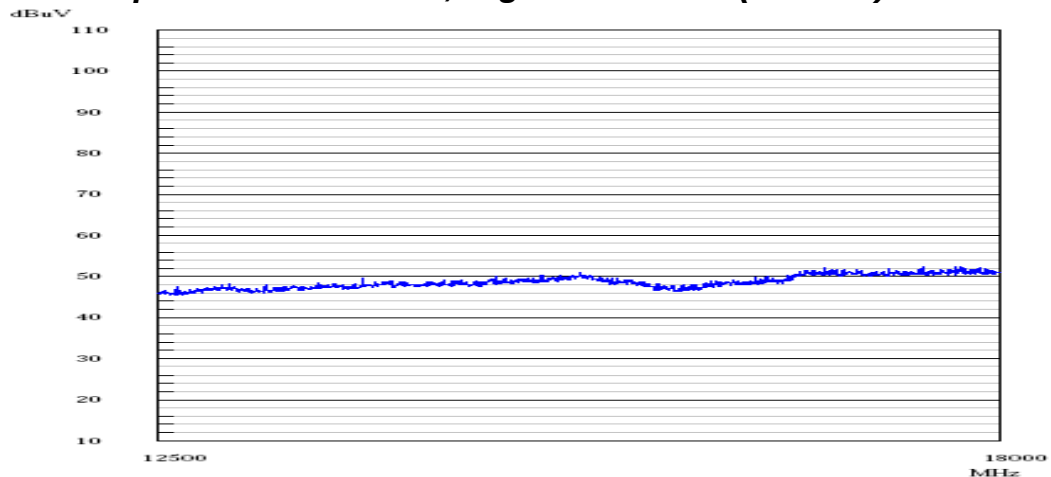
Radiated Spurious Emissions, Highest Channel(Vertical)



Radiated Spurious Emissions, Highest Channel(Vertical)



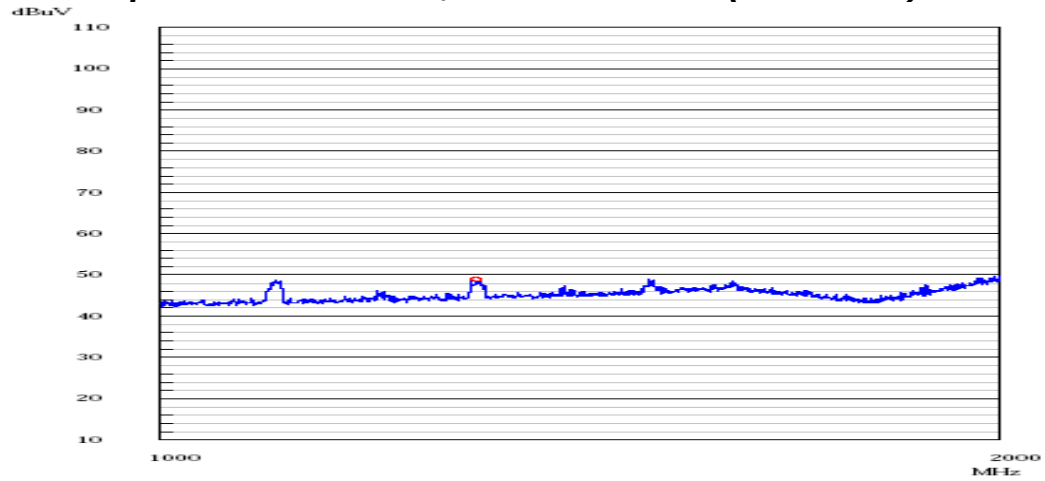
Radiated Spurious Emissions, Highest Channel(Vertical)



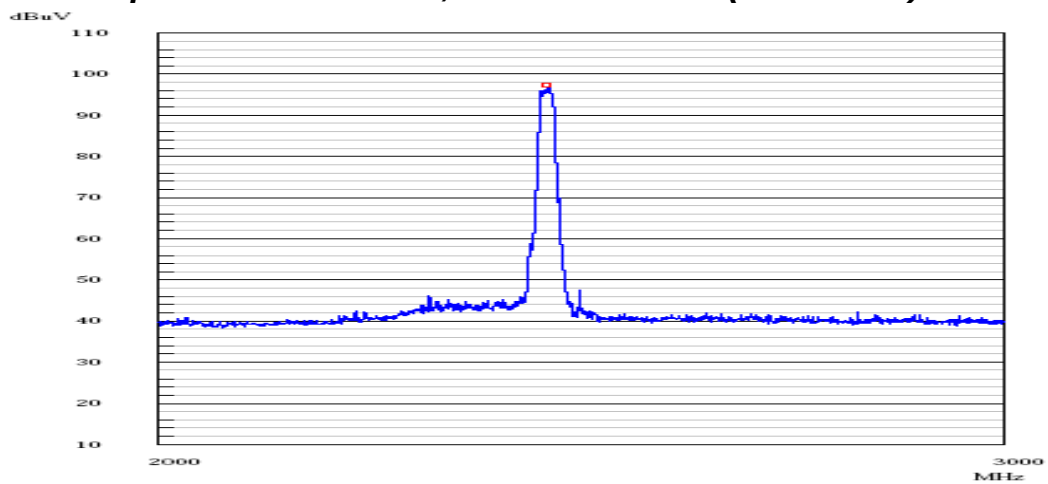
PLOT OF TEST DATA

- 802.11g -

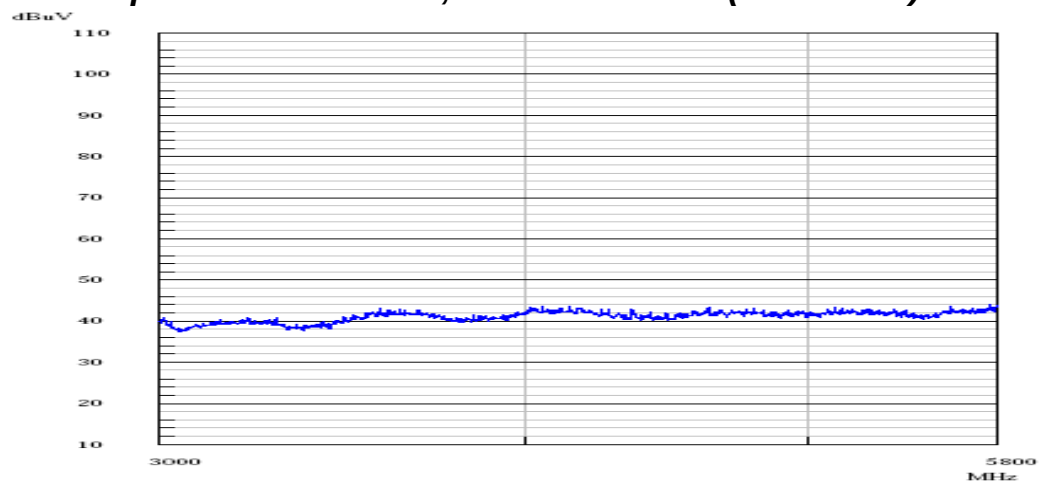
Radiated Spurious Emissions, Lowest Channel(Horizontal)



Radiated Spurious Emissions, Lowest Channel(Horizontal)

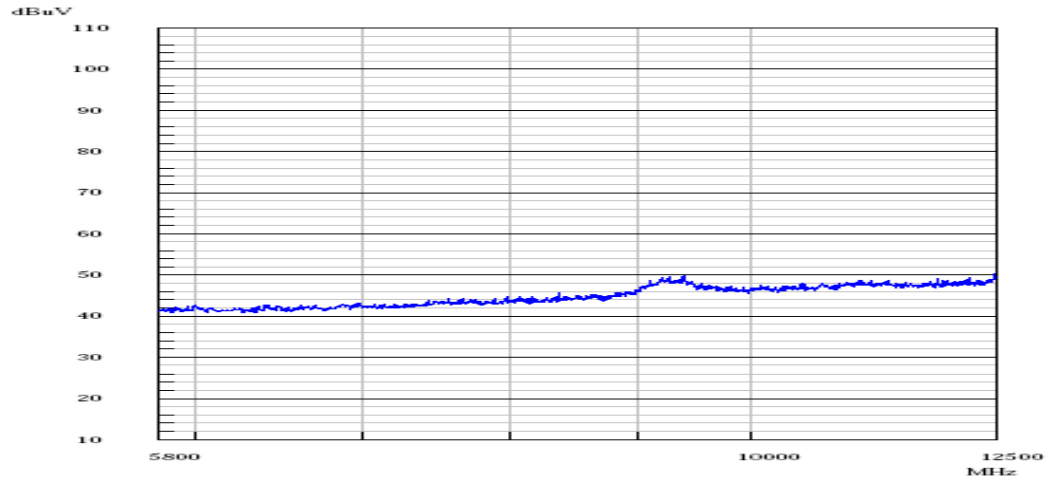


Radiated Spurious Emissions, Lowest Channel(Horizontal)

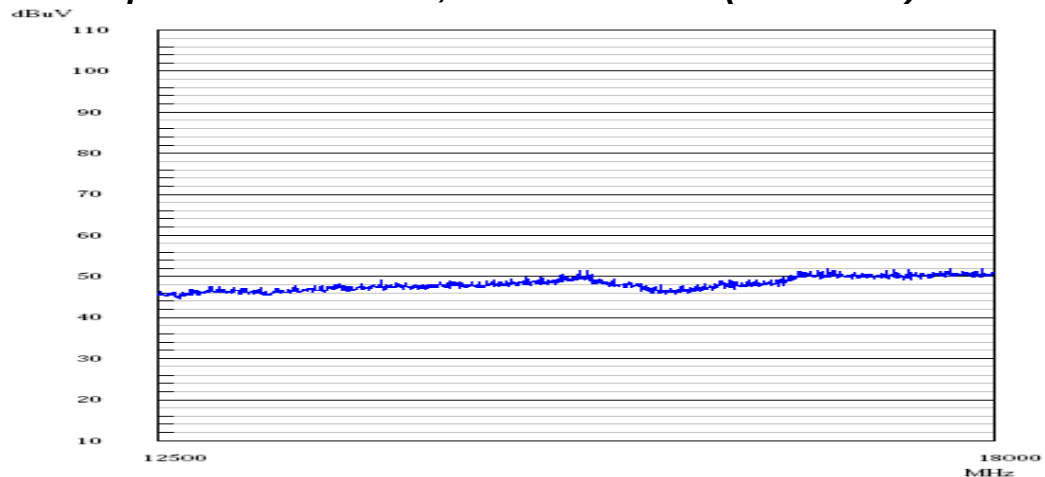


PLOT OF TEST DATA

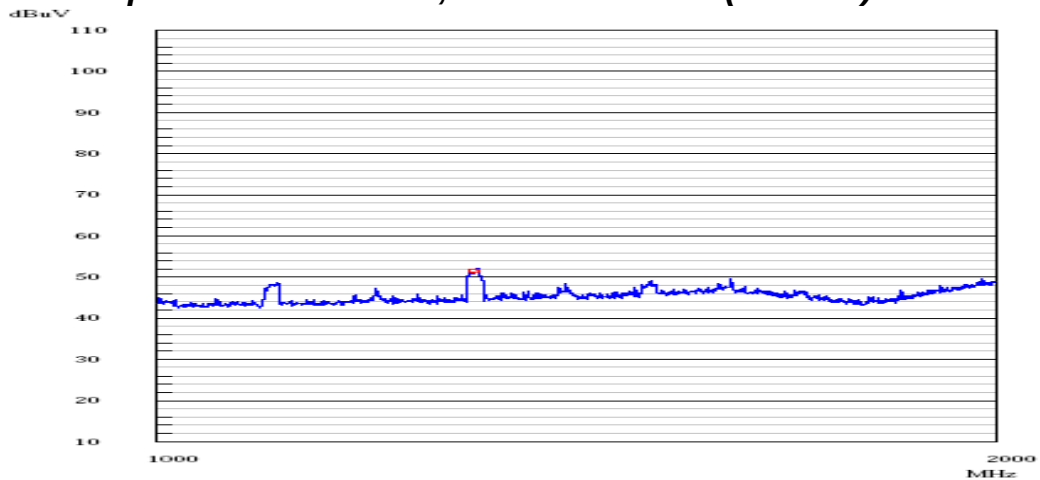
Radiated Spurious Emissions, Lowest Channel(Horizontal)



Radiated Spurious Emissions, Lowest Channel(Horizontal)

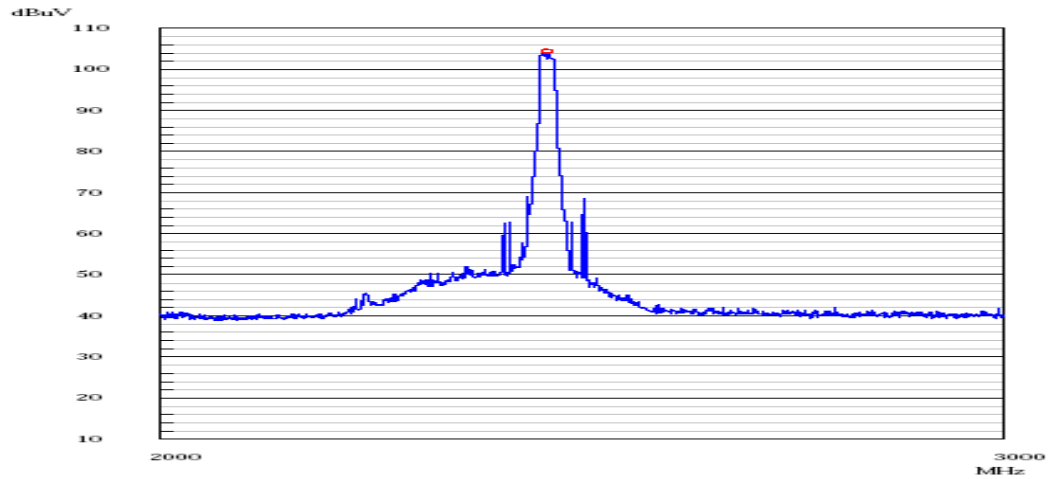


Radiated Spurious Emissions, Lowest Channel(Vertical)

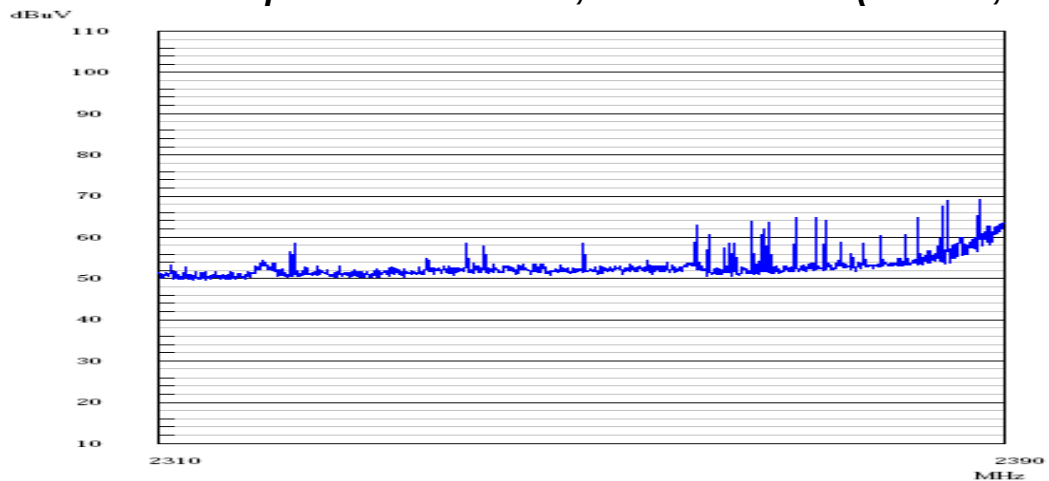


PLOT OF TEST DATA

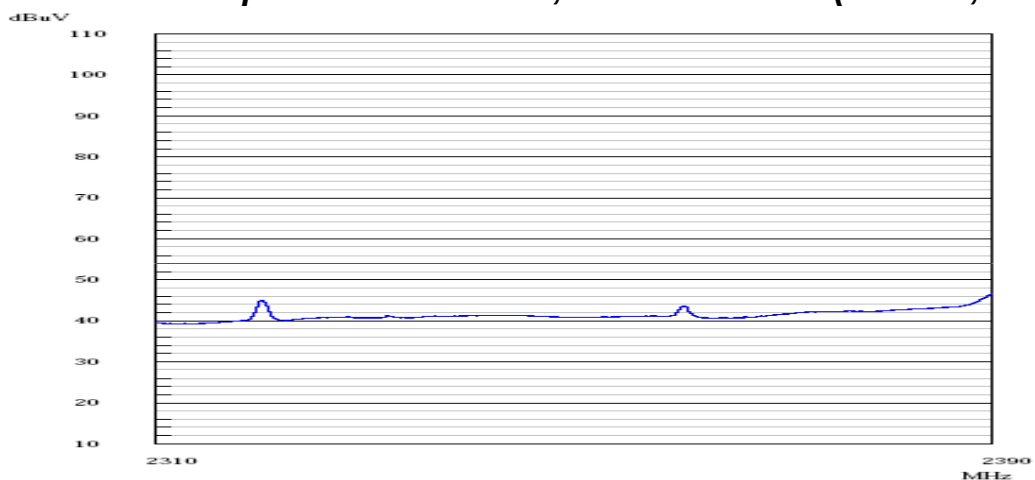
Radiated Spurious Emissions, Lowest Channel(Vertical)



Restricted Band Spurious Emissions, Lowest channel(Vertical, Peak)

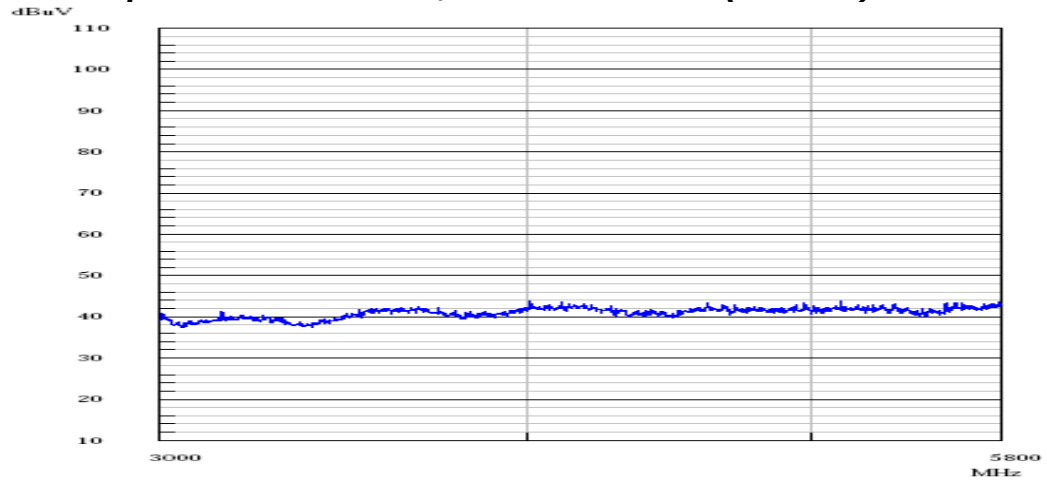


Restricted Band Spurious Emissions, Lowest channel(Vertical, Average)

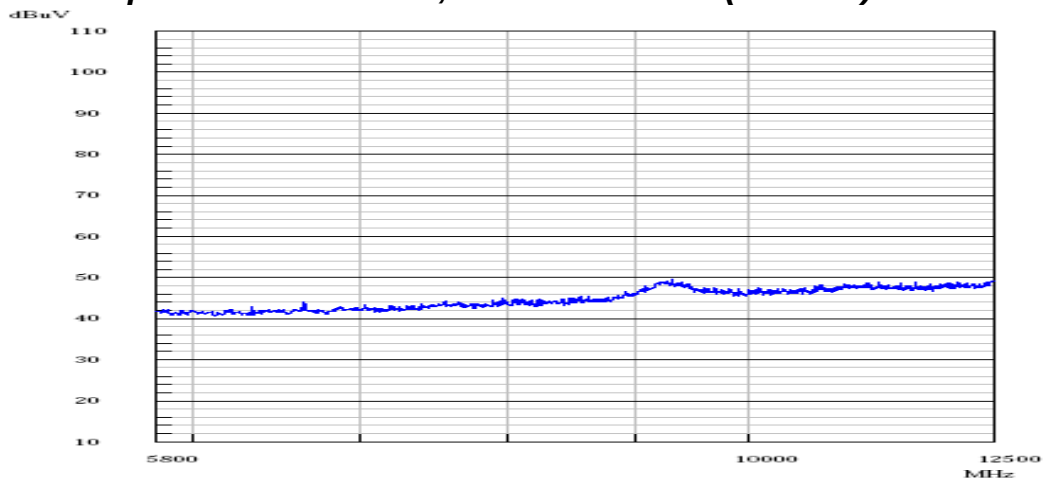


PLOT OF TEST DATA

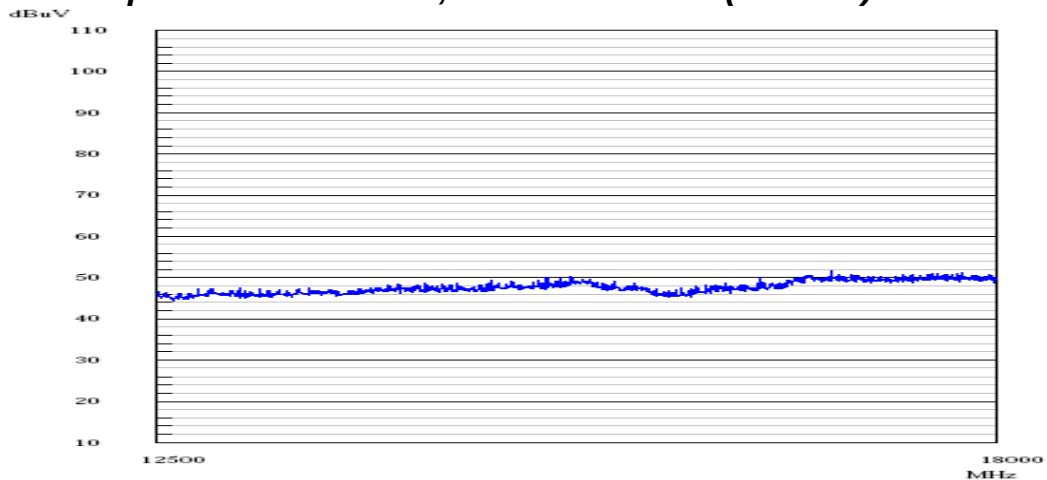
Radiated Spurious Emissions, Lowest Channel(Vertical)



Radiated Spurious Emissions, Lowest Channel(Vertical)

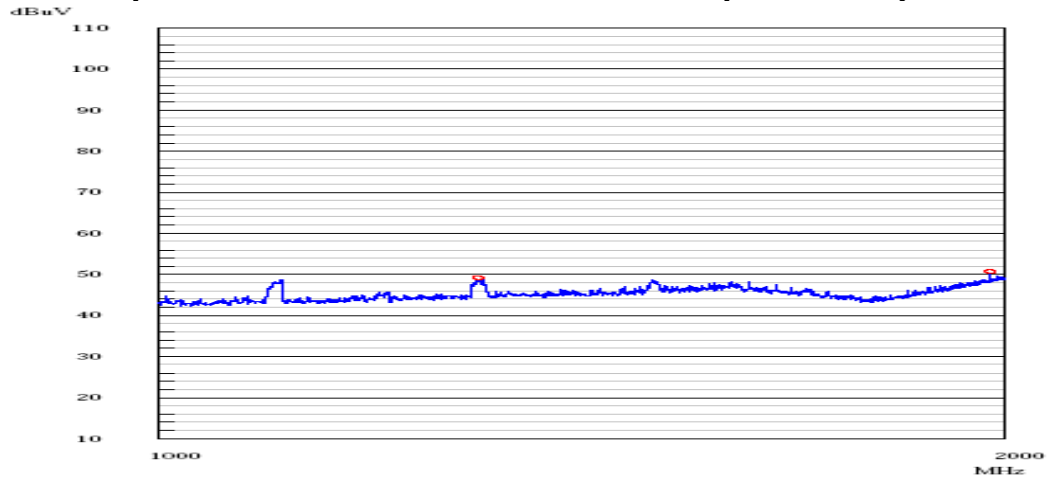


Radiated Spurious Emissions, Lowest Channel(Vertical)

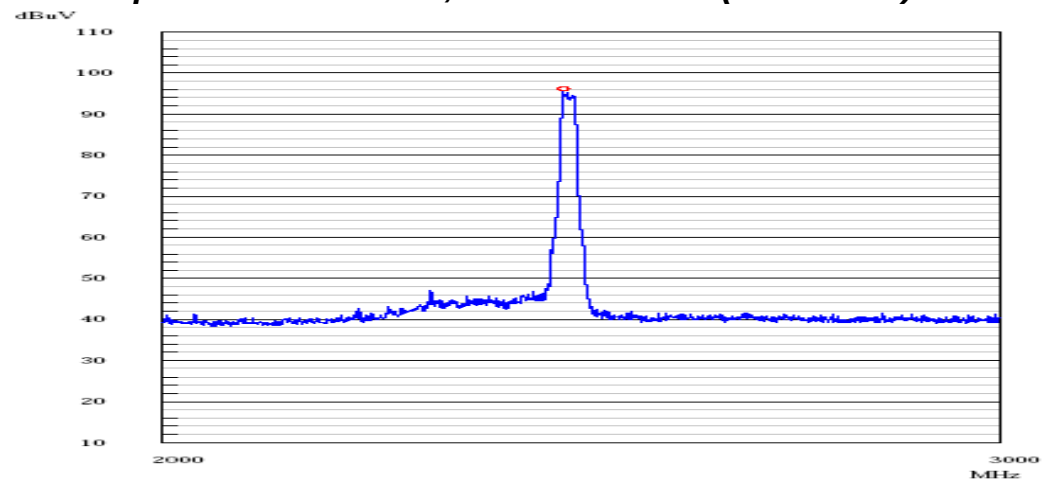


PLOT OF TEST DATA

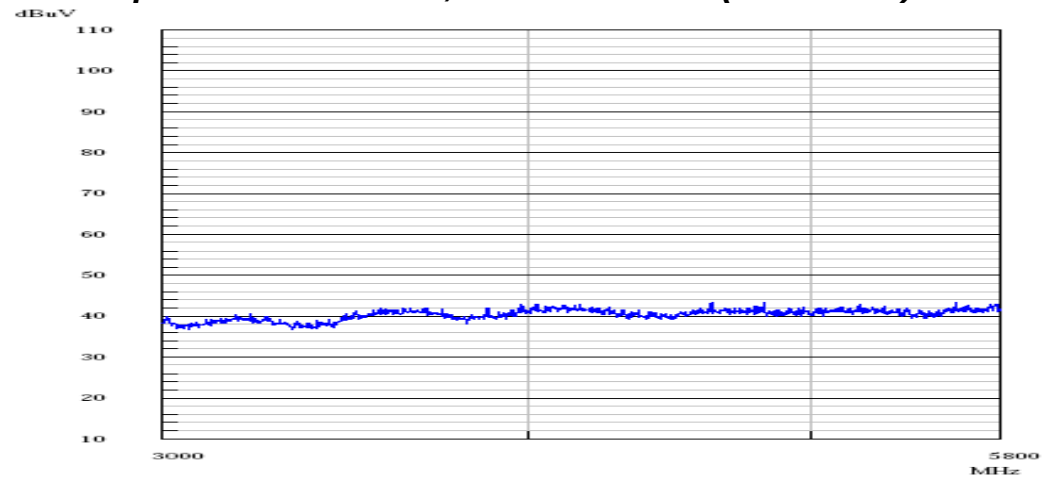
Radiated Spurious Emissions, Middle Channel(Horizontal)



Radiated Spurious Emissions, Middle Channel(Horizontal)

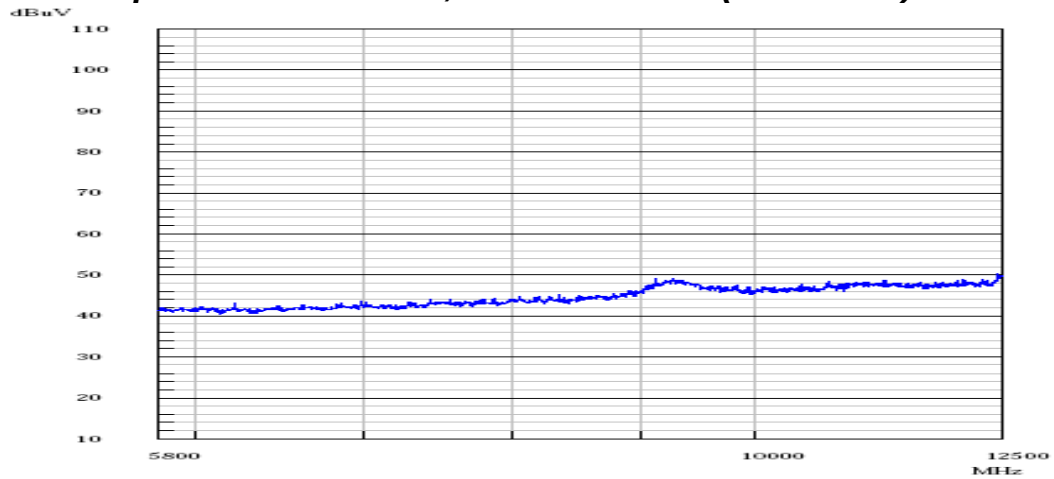


Radiated Spurious Emissions, Middle Channel(Horizontal)

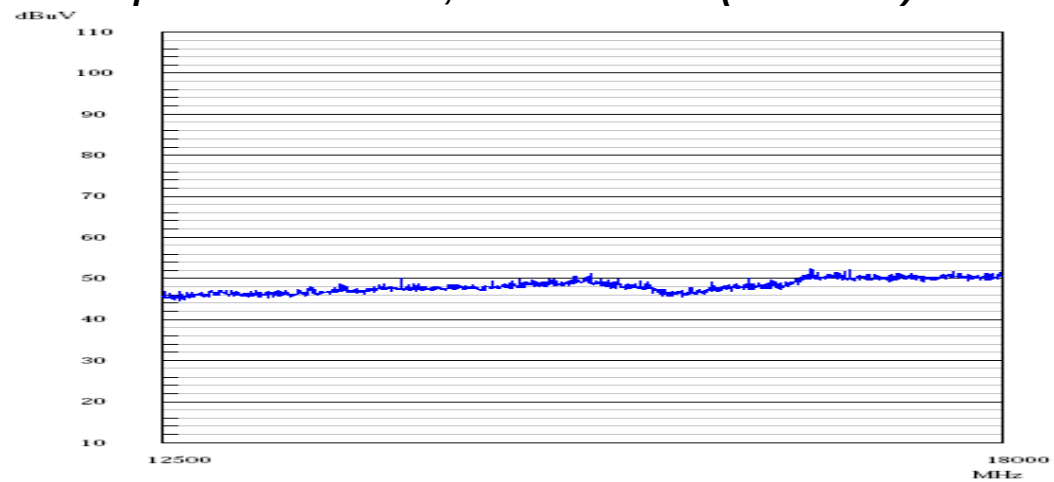


PLOT OF TEST DATA

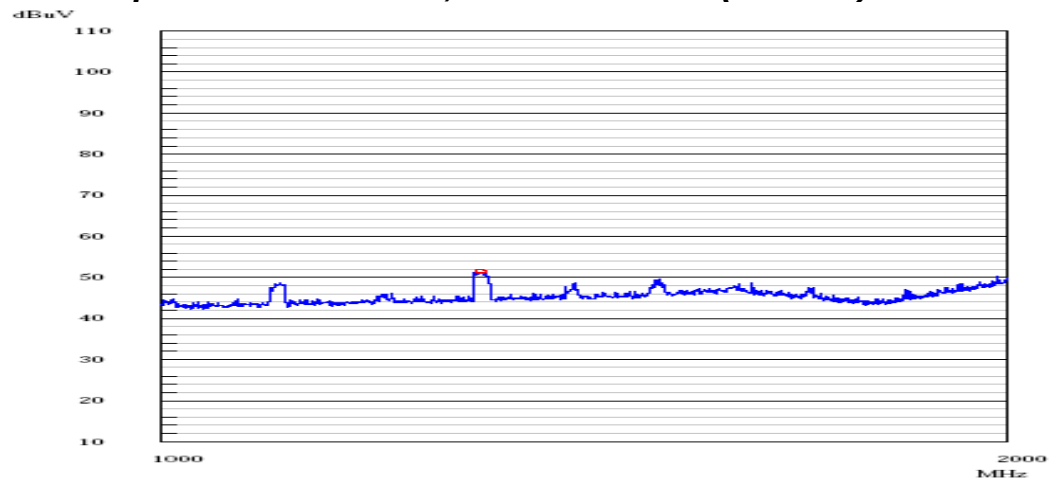
Radiated Spurious Emissions, Middle Channel(Horizontal)



Radiated Spurious Emissions, Middle Channel(Horizontal)

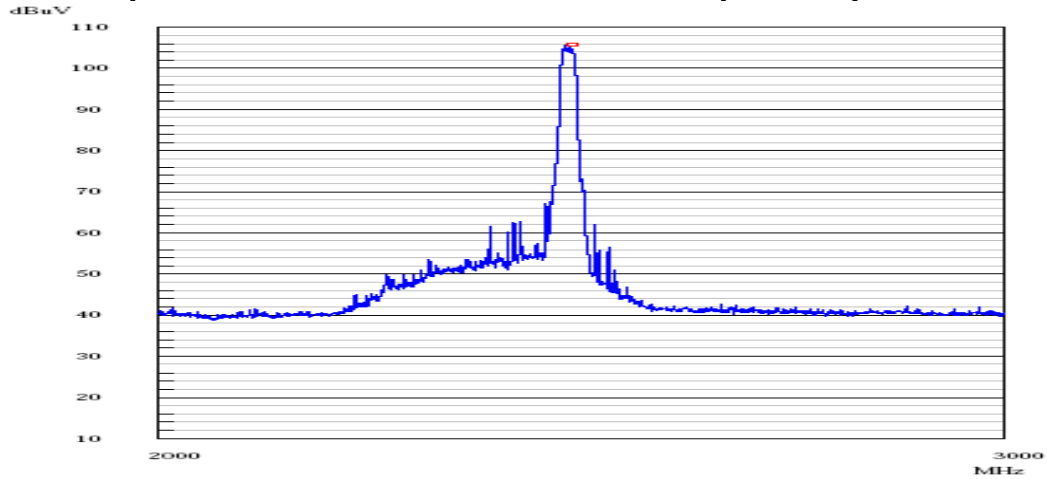


Radiated Spurious Emissions, Middle Channel(Vertical)

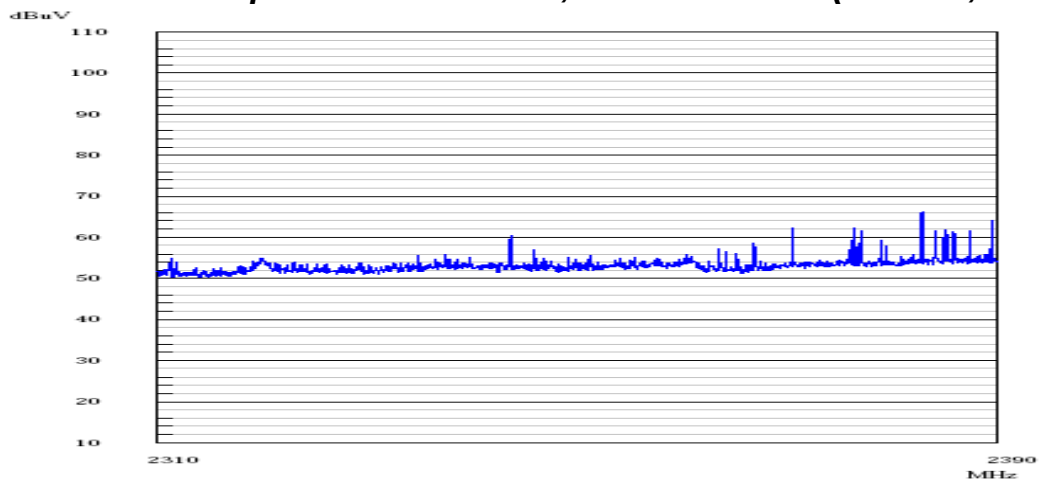


PLOT OF TEST DATA

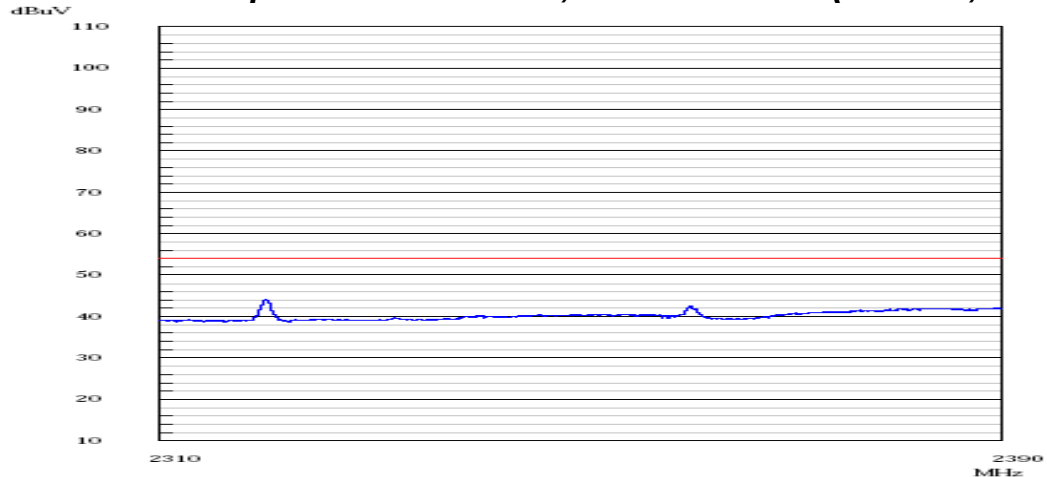
Radiated Spurious Emissions, Middle Channel(Vertical)



Restricted Band Spurious Emissions, Middle channel(Vertical, Peak)

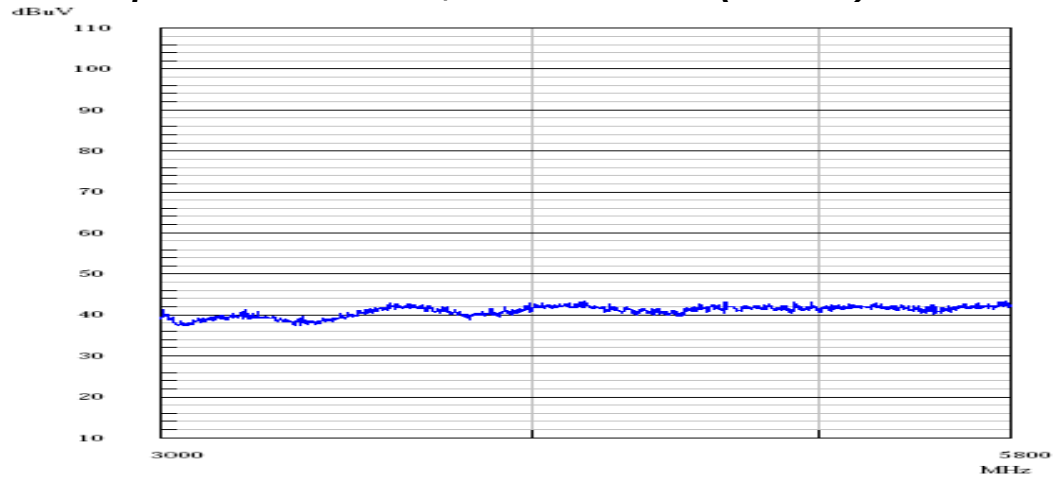


Restricted Band Spurious Emissions, Middle channel(Vertical, Average)

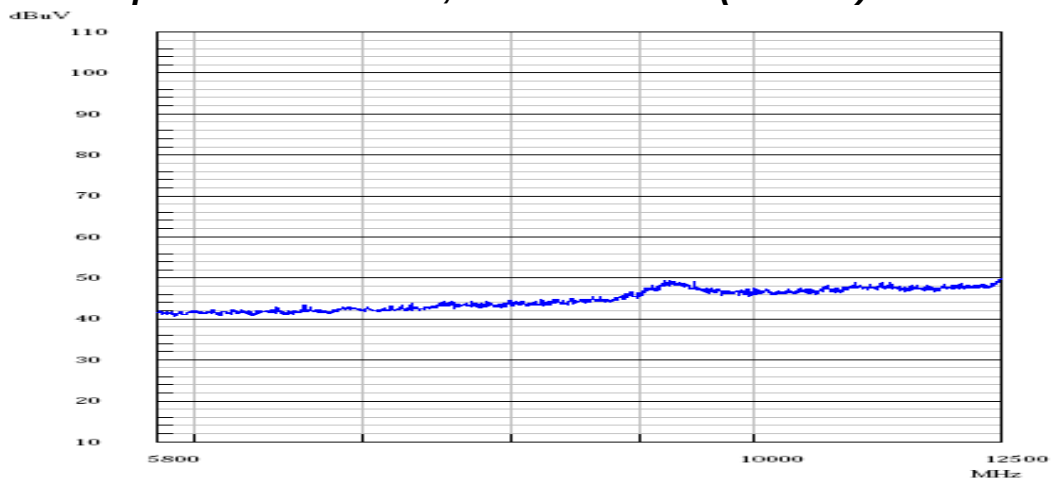


PLOT OF TEST DATA

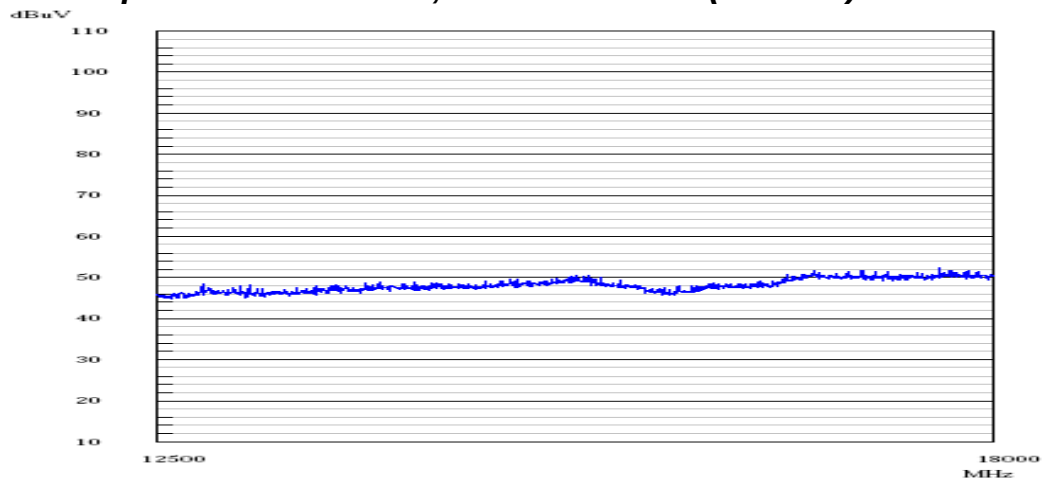
Radiated Spurious Emissions, Middle Channel(Vertical)



Radiated Spurious Emissions, Middle Channel(Vertical)

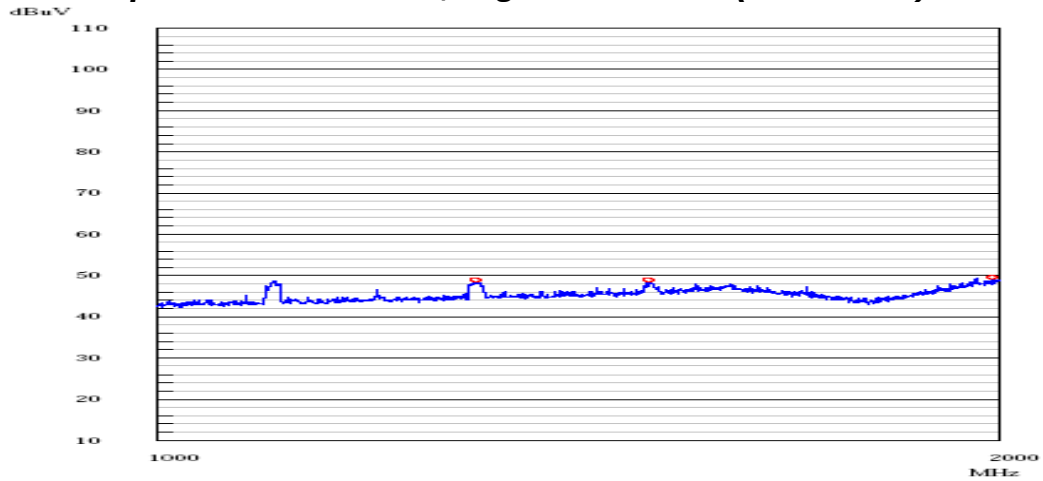


Radiated Spurious Emissions, Middle Channel(Vertical)

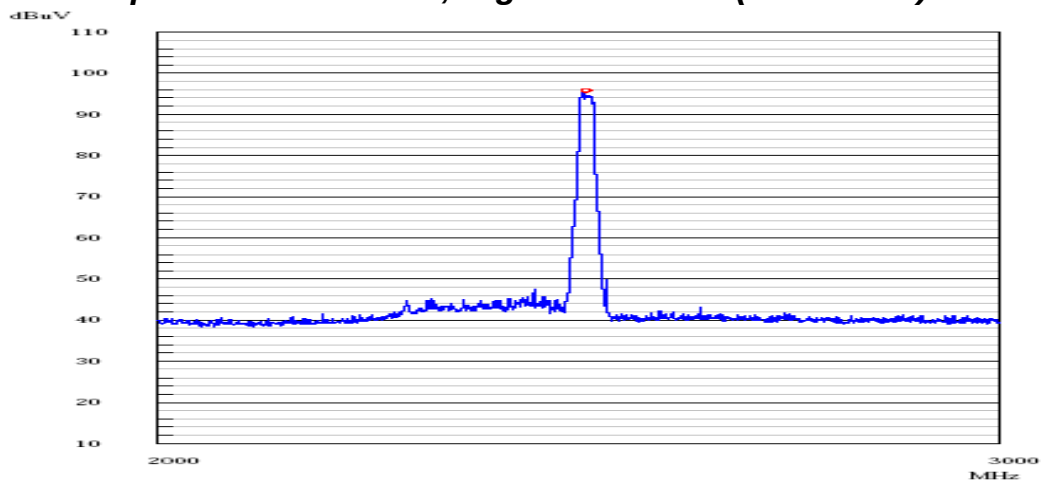


PLOT OF TEST DATA

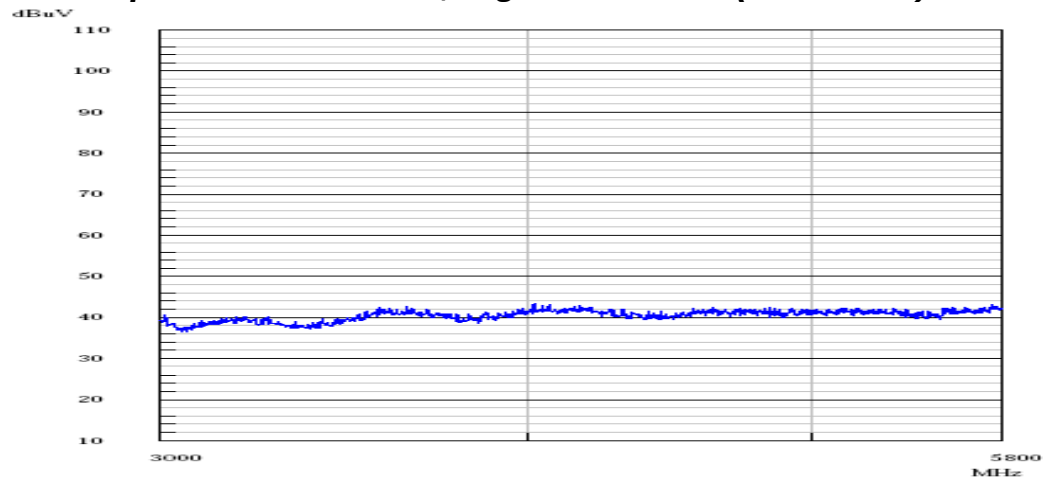
Radiated Spurious Emissions, Highest Channel(Horizontal)



Radiated Spurious Emissions, Highest Channel(Horizontal)

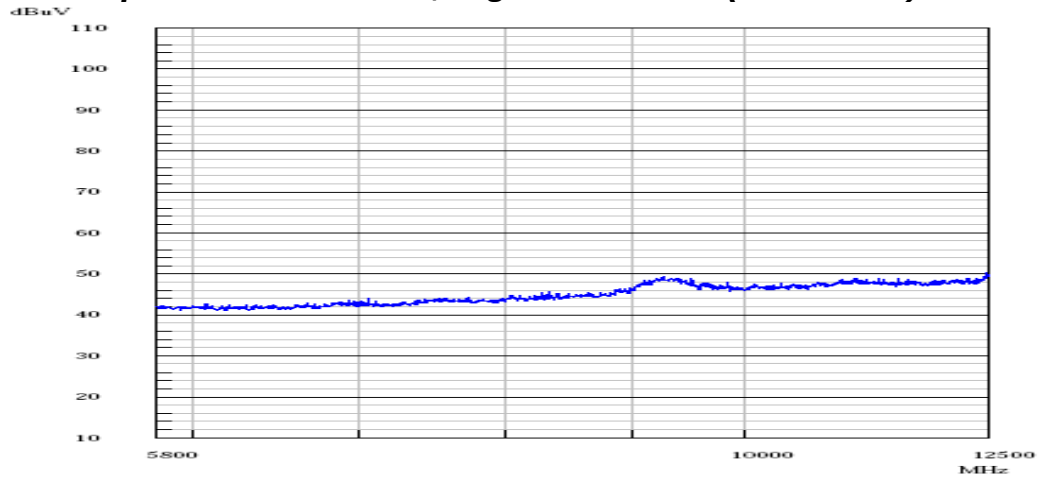


Radiated Spurious Emissions, Highest Channel(Horizontal)

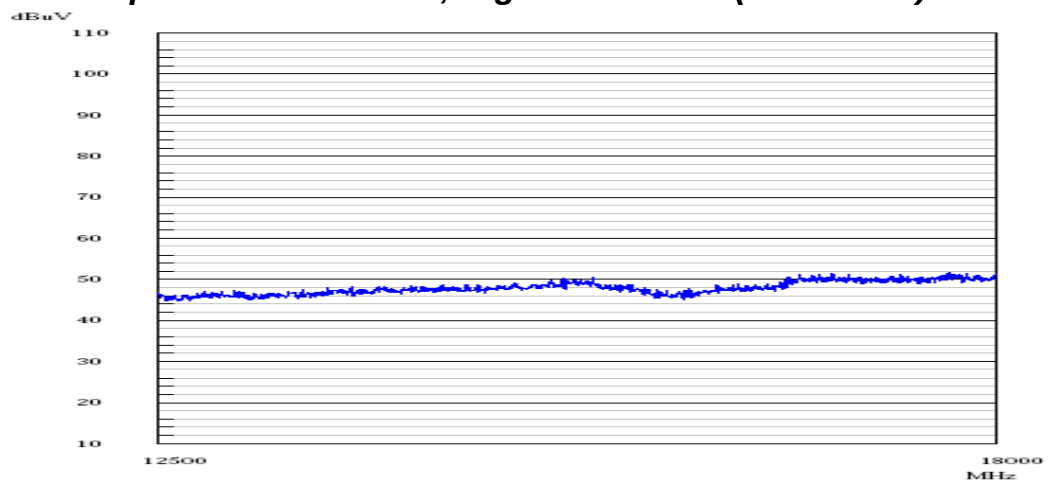


PLOT OF TEST DATA

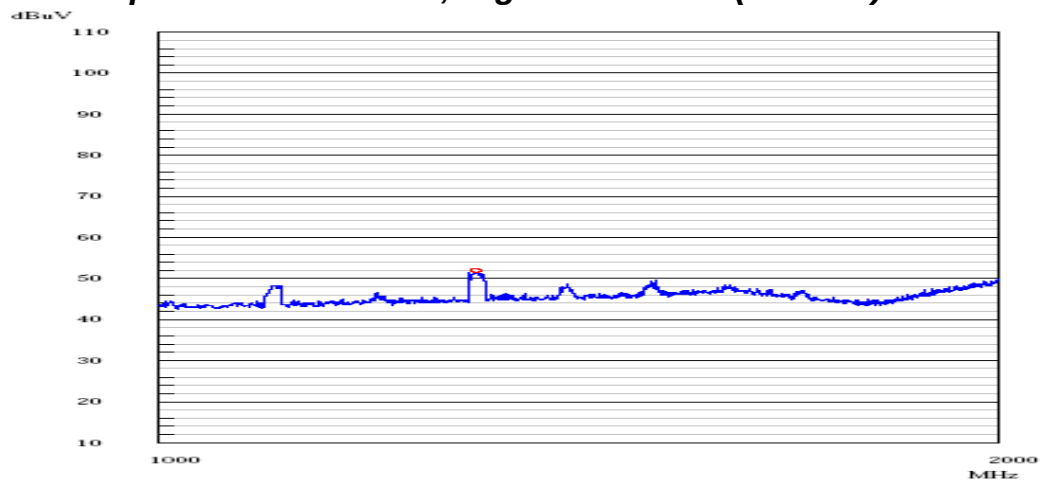
Radiated Spurious Emissions, Highest Channel(Horizontal)



Radiated Spurious Emissions, Highest Channel(Horizontal)

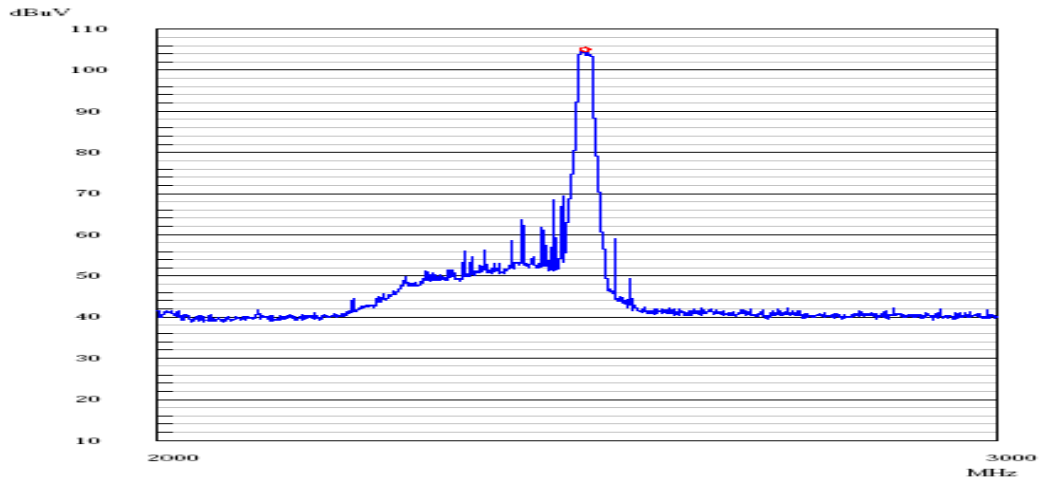


Radiated Spurious Emissions, Highest Channel(Vertical)

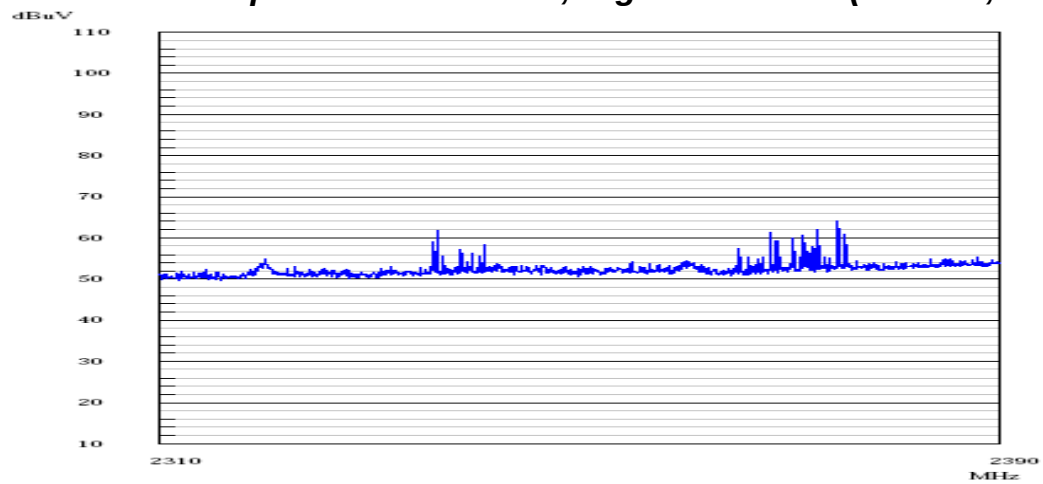


PLOT OF TEST DATA

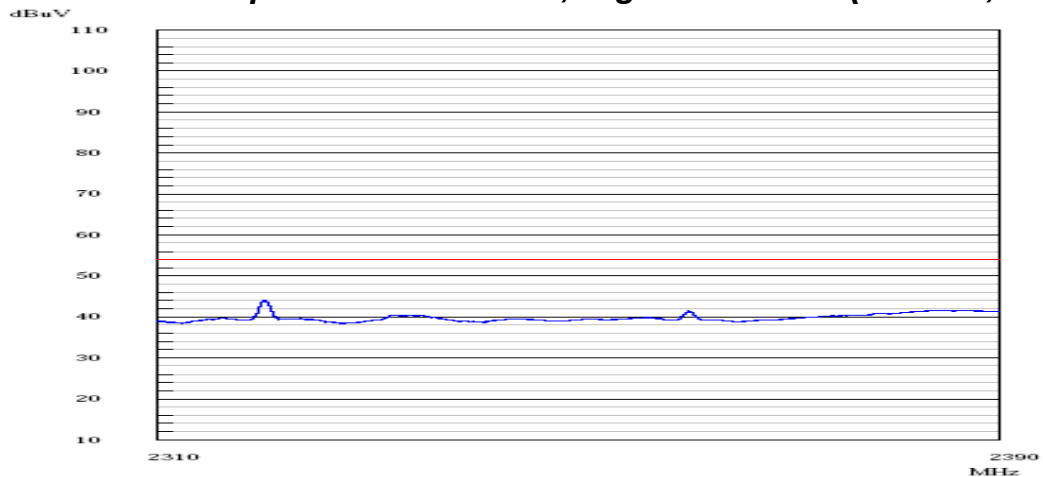
Radiated Spurious Emissions, Highest Channel(Vertical)



Restricted Band Spurious Emissions, Highest channel(Vertical, Peak)

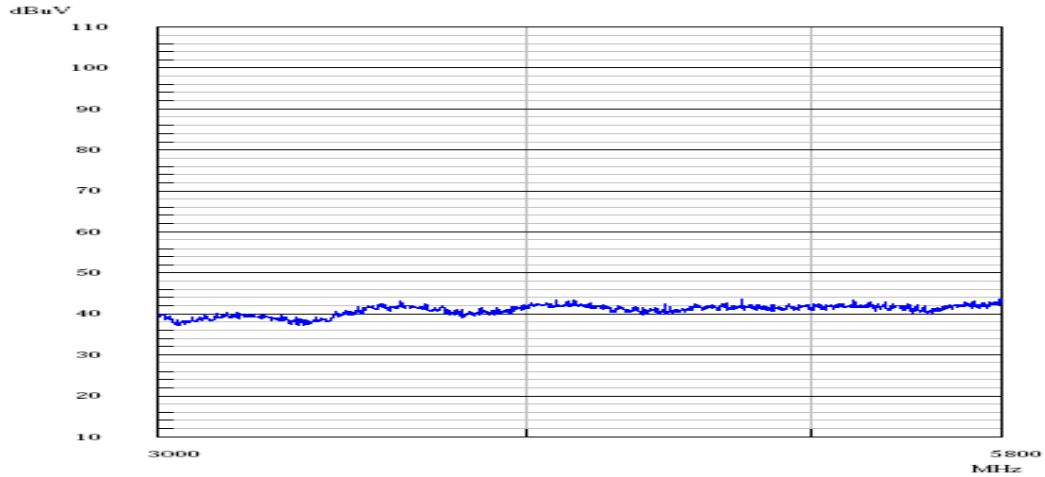


Restricted Band Spurious Emissions, Highest channel(Vertical, Average)

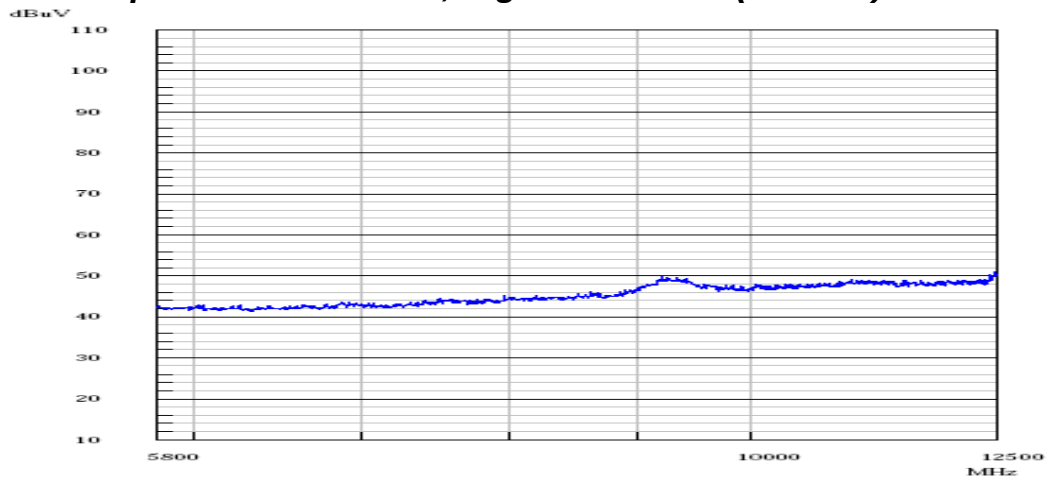


PLOT OF TEST DATA

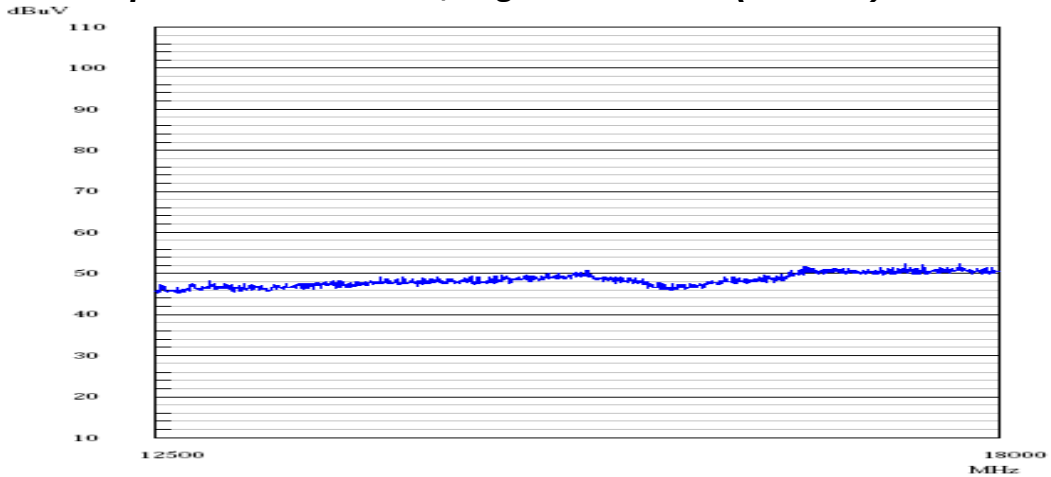
Radiated Spurious Emissions, Highest Channel(Vertical)



Radiated Spurious Emissions, Highest Channel(Vertical)



Radiated Spurious Emissions, Highest Channel(Vertical)



TEST DATA

Peak Power Spectral Density – 15.247(d)

FCC ID : A3LWIP5001A

Test Mode : Set to Lowest channel, Middle channel and Highest channel.

- 802.11b mode -

Channel	Frequency(MHz)	Result(dBm)	Limit(dBm)	Margin(dB)
1	2412	-8.66	8	-16.66
6	2437	-7.24	8	-15.24
11	2462	-8.00	8	-16.00

- 802.11g mode -

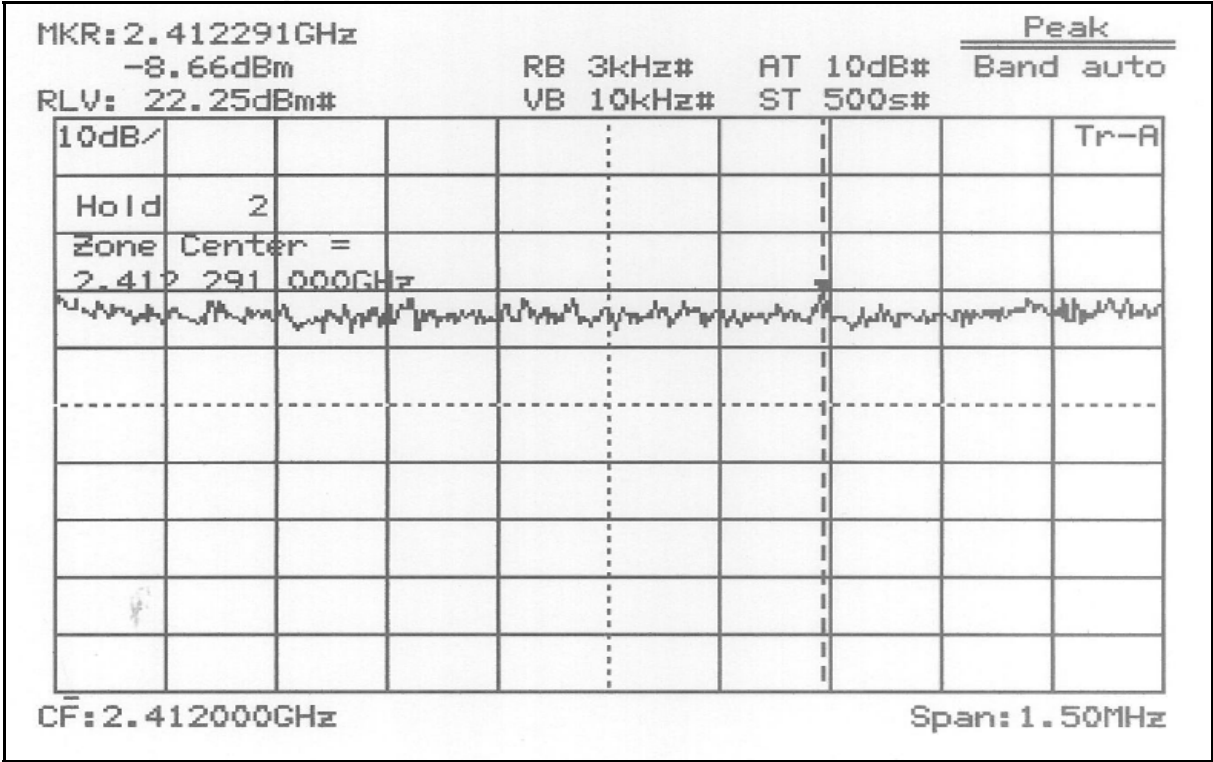
Channel	Frequency(MHz)	Result(dBm)	Limit(dBm)	Margin(dB)
1	2412	-12.94	8	-20.94
6	2437	-13.04	8	-21.04
11	2462	-13.72	8	-21.72



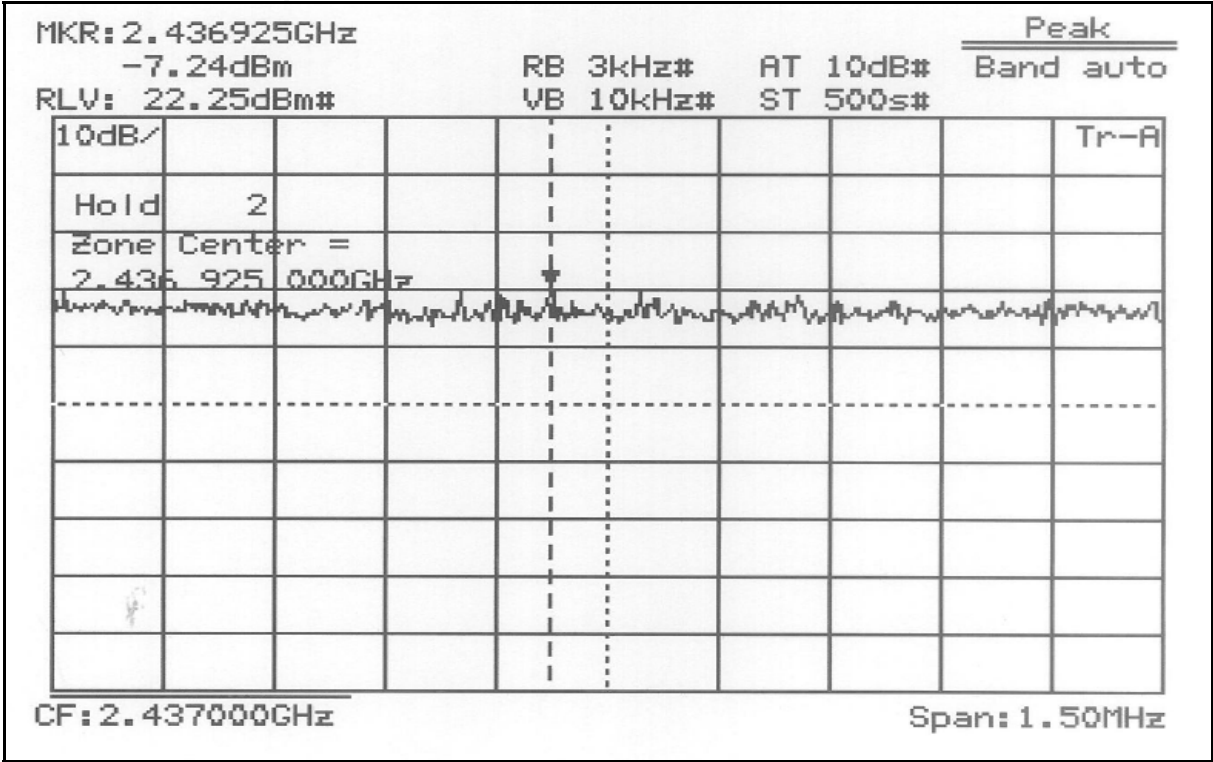
Tested by **M. C. Shin**

PLOT OF TEST DATA

- 802.11b mode -
Peak Power Spectral Density, Lowest Channel

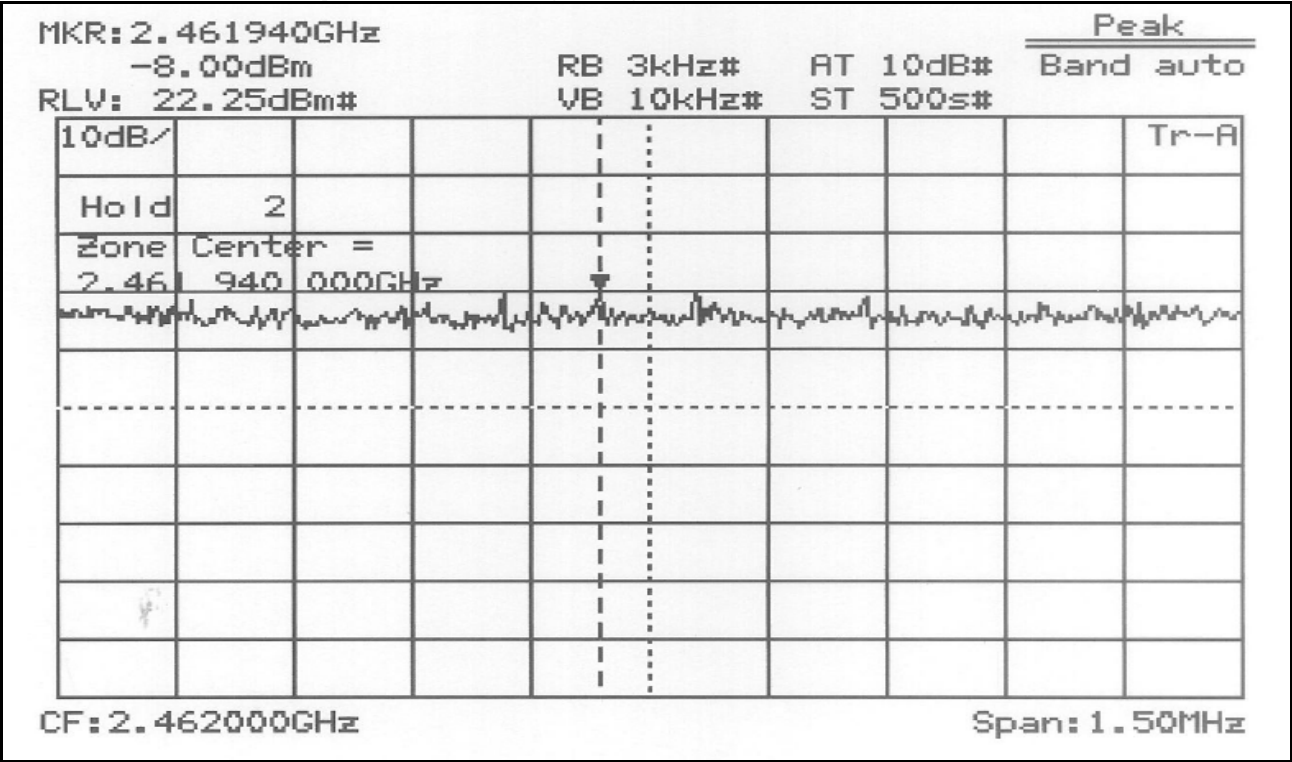


Peak Power Spectral Density, Middle Channel



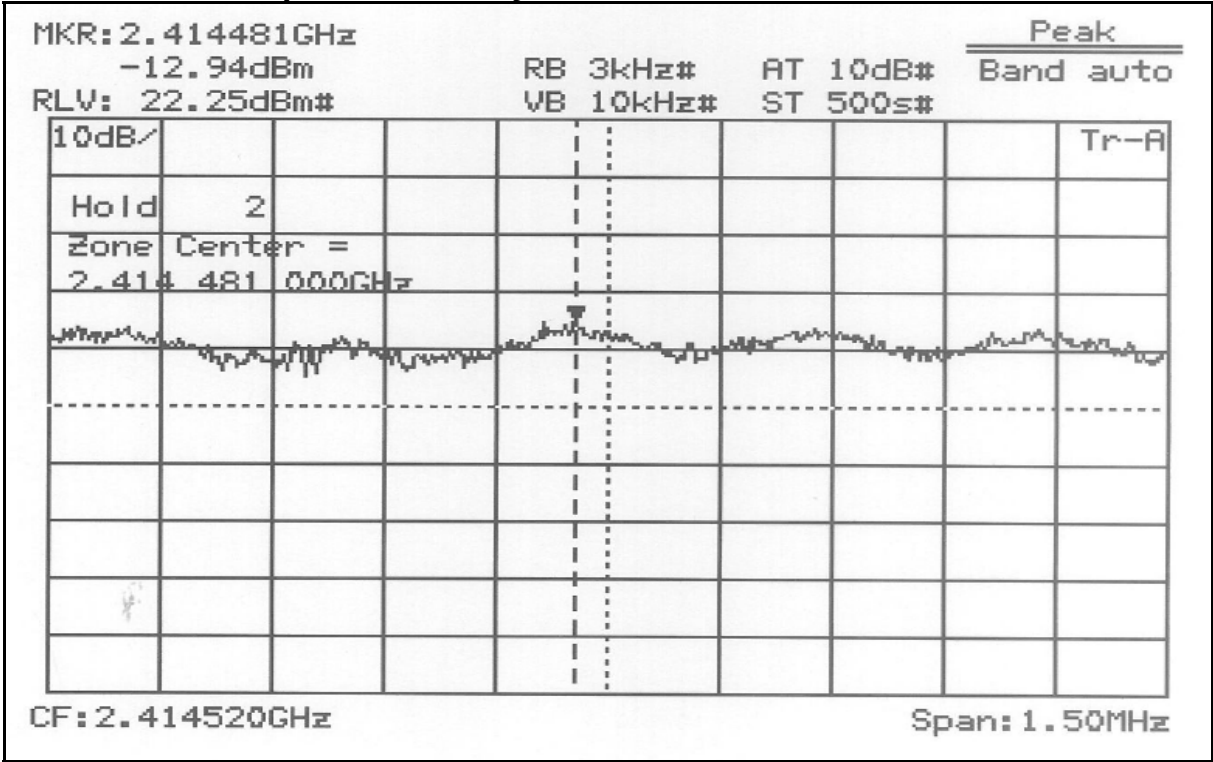
PLOT OF TEST DATA

Peak Power Spectral Density, Highest Channel



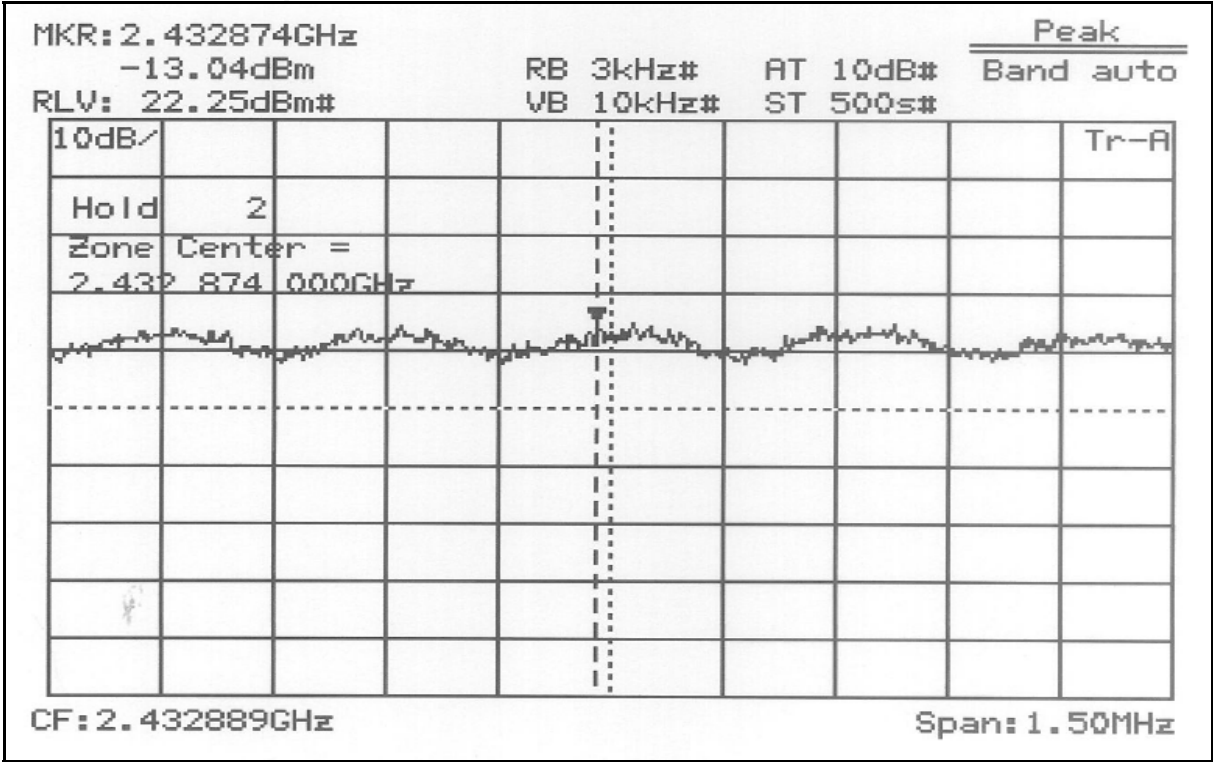
- 802.11g mode -

Peak Power Spectral Density, Lowest Channel

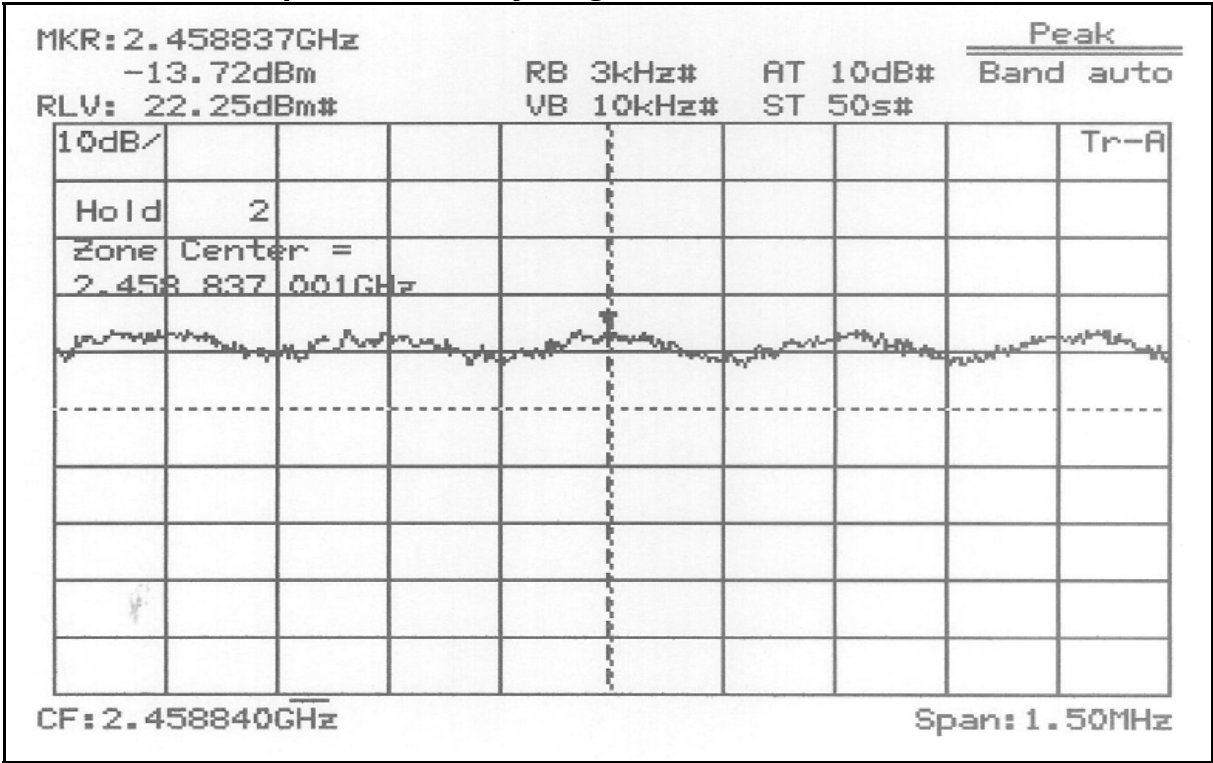


PLOT OF TEST DATA

Peak Power Spectral Density, Middle Channel



Peak Power Spectral Density, Highest Channel



TEST DATA

MAXIMUM PERMISSIBLE EXPOSURE

RF Exposure Limit

According to FCC 1.1310: The criteria listed in the following table shall be used to evaluate the Environmental of human exposure to radio frequency (RF) radiation as specified in 1.1307(b)

Limits for Maximum Permissible Exposure (MPE)

Frequency Range(MHz)	Electric Field Strength(V/m)	Magnetic Field Strength(A/m)	Power Density (mW/cm ²)	Averaging Time (Minutes)
(A) Limits for occupational / Contral Exposure				
30 - 300	61.4	0.163	1	6
300 - 1500	...	...	F/300	6
1500 - 100000	...	...	5	6
(B) Limits for General Population / Uncontrolled Exposure				
30 - 300	27.5	0.073	0.2	30
300 - 1500	...	...	F/1500	30
1500 - 100000	...	...	1	30

F = Frequency (MHz)

Fries formula

Fries transmission formula : $P_d = (P_{out} * G) / (4 * \pi * r^2)$

$$r = \sqrt{((P_{out} * G) / 4 * \pi * P_d)}$$

Where

P_d = Power density in mW/cm²

P_{out} = Output power to antenna in mW

G = Gain of antenna in linear scale

π = 3.1416

r = Distance between observation point center of the radiator in cm

P_d is the limit of MPE, 1 mW/cm². If we know the Maximum Gain of the antenna and the total power input to the antenna, through the calculation, we will know the distance r where the MPE limit is reached.

TEST DATA

Test Result

The maximum antenna gain is 4dBi or 2.512(Numeric)

Output power into antenna and RF Exposure Distance

Channel	Frequency (MHz)	Output Power to Antenna(mW)	RF Exposure Distance (cm)
1	2412	43.05	2.93
6	2437	41.40	2.88
11	2462	39.90	2.82

MPE Safe Distance =2.93cm



Tested by **M. C. Shin**

ACCURACY OF MEASUREMENT

The Measurement Uncertainties stated were calculated in accordance with the requirements of NIST Technical Note 1297 with the confidence level of 95%

1. Radiation Uncertainty Calculation

Contribution	Probability Distribution	Uncertainty(+/-dB)
Antenna Factor	Normal (k=2)	± 0.5
Cable Loss	Normal (k=2)	± 0.04
Receiver Specification	Rectangular	± 2.0
Antenna directivity	Rectangular	± 1.0
Antenna Factor variation with Height		
Antenna Phase Center Variation		
Antenna Factor Frequency Interpolation		
Measurement Distance Variation		
Site Imperfections	Rectangular	± 2.0
Mismatch:Receiver VRC $r_i=0.3$ Antenna VRC $r_R=0.1(B_i)0.4(L_p)$ Uncertainty Limits $20\log(1\pm r_i r_R)$	U-Shaped	$+ 0.25 / - 0.26$
System Repeatibility	Std.deviation	± 0.05
Repeatability of EUT	-	-
Combined Standard Uncertainty	Normal	± 1.77
Expanded Uncertainty U	Normal (k=2)	± 3.5

2. Conducted Uncertainty Calculation

Contribution	Probability Distribution	Uncertainty(+/-dB)
Receiver Specification	Normal (k=2)	± 2.0
LISN coupling spec.	Normal (k=2)	± 0.4
Cable and input attenuator cal.	Rectangular	± 0.4
Mismatch:Receiver VRC $r_i=0.3$ LISN vrc $r_g=0.1$ Uncertainty Limits $20\log(1\pm r_i r_R)$	U-Shaped	± 0.26
System Repeatibility	Std.deviation	± 0.68
Repeatability of EUT	-	-
Combined Standard Uncertainty	Normal	± 1.18
Expanded Uncertainty U	Normal (k=2)	± 2.4

TEST EQUIPMENT

No.	Instrument	Manufacturer	Model	Calibration Date
1	*Test Receiver	R & S	ESCS 30	2005.08
2	*Test Receiver	R & S	ESCS 30	2004.12
3	*Amplifier	HP	8447F	2005.07
4	*Amplifier	HP	8447F	2004.10
5	*Spectrum Analyzer	HP	8568B	2004.10
6	*Spectrum Analyzer	Anritsu	MS2668C	2004.12
7	*Spectrum Analyzer	HP	8593E	2004.10
8	*Logbicon Super Antenna	Schwarzbeck	VULB9166	2005.05
9	*Biconical Log Antenna	ARA	LPB-2520/A	2005.01
10	*Horn Antenna	Schwarzbeck	BBHA 9120D	2005.04
11	*Horn Antenna	R & S	HF906	2005.03
12	*Signal Generater	R & S	SMP02	2005.03
13	*Signal Generater	HP	E4436B	2005.01
14	*LISN	R & S	ESH3-Z5	2004.10
15	LISN	Kyoritsu	KNW-408	2004.12
16	*LISN	Kyoritsu	KNW-407	2005.03
17	*Position Controller	EM Eng.	N/A	N/A
18	*Turn Table	EM Eng.	N/A	N/A
19	*Antenna Mast	EM Eng.	N/A	N/A
20	*Anechoic Chamber	EM Eng.	N/A	N/A
21	*Shielded Room	EM Eng.	N/A	N/A
22	*Power Meter	R & S	NRVS	2004.12
23	*Peak Power Sensor	R & S	NRV-Z32	2004.12

*) Test equipment used during the test

APPENDIX A – LABELLING REQUIREMENTS

Labelling Requirements

The sample label shown shall be *permanently affixed* at a conspicuous location on the device and be readily visible to the user at the time of purchase.

FCC ID : A3LSIT200EMRB

Brand Name : SAMSUNG

This device complies with part 15 of the FCC Rules. Operation is subject to the following two conditions : (1) This device may not cause harmful interference, and (2) this device must accept any interference received, including interference that may cause undesired operation.



APPENDIX B – CIRCUIT DIAGRAM

APPENDIX C – PHOTOGRAPHS OF TEST SET-UP

The **Conducted Test Picture** and **Radiated Test Picture** and show the worst-case configuration and cable placement.

- **Conducted Test Picture(Front)**



- **Conducted Test Picture(Rear)**



● Radiated Test Picture(Front)



● Radiated Test Picture(Rear)



APPENDIX D – EUT PHOTOGRAPHS

- **Front View of EUT**



- Rear View of EUT



- Ports View of EUT



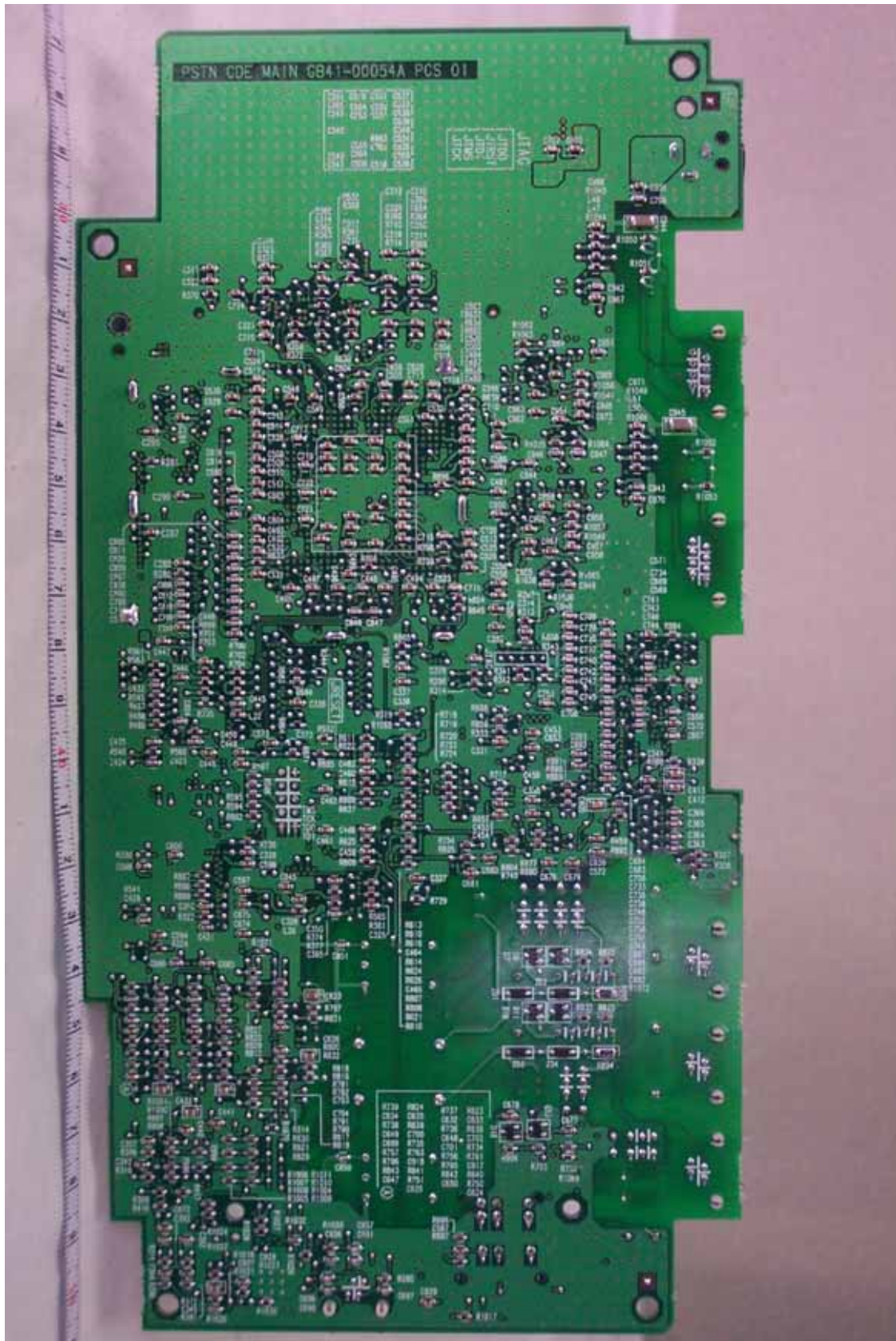
- Inside View of EUT



- Front View of Main Board



● Rear View of Main Board



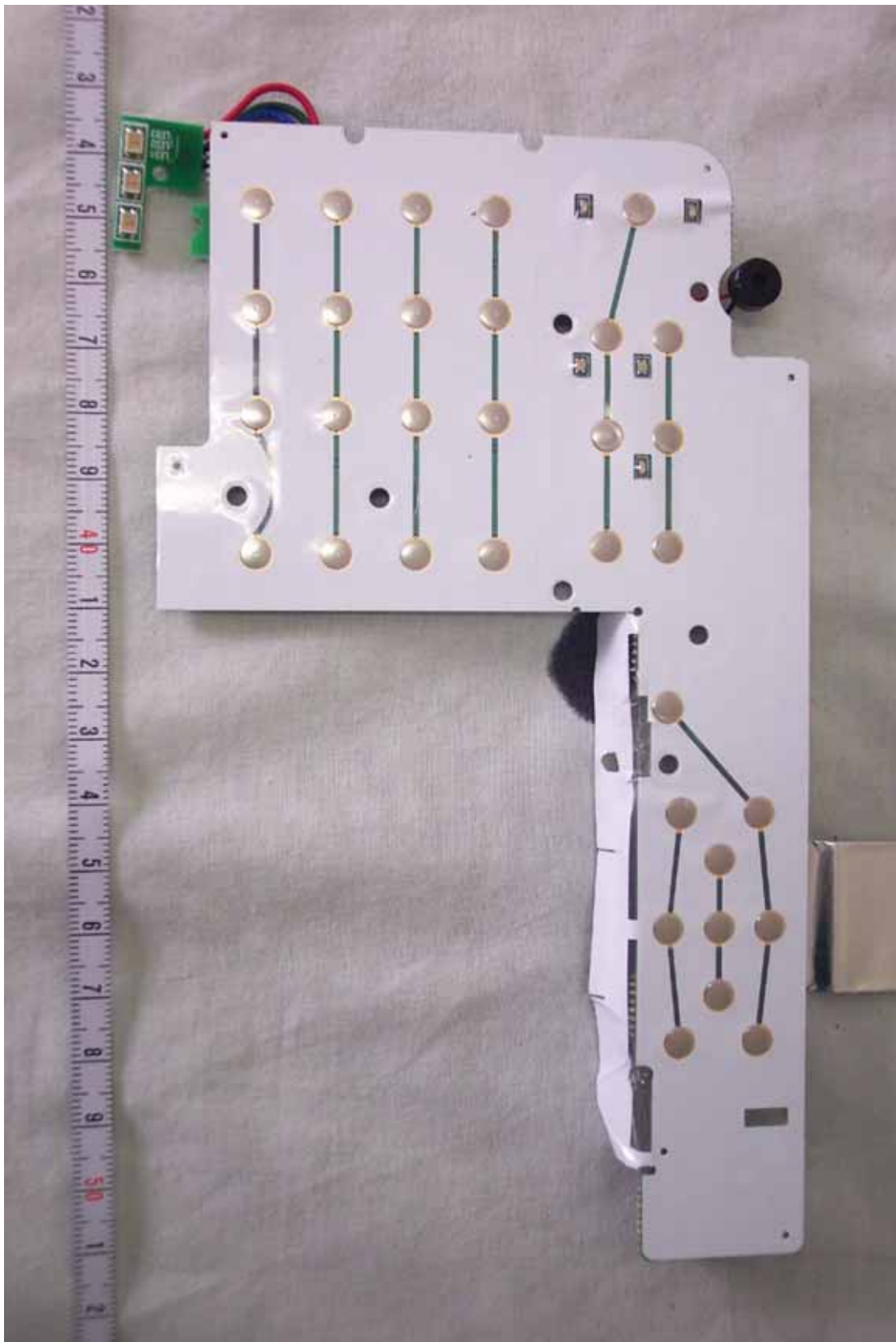
- Front View of LCD



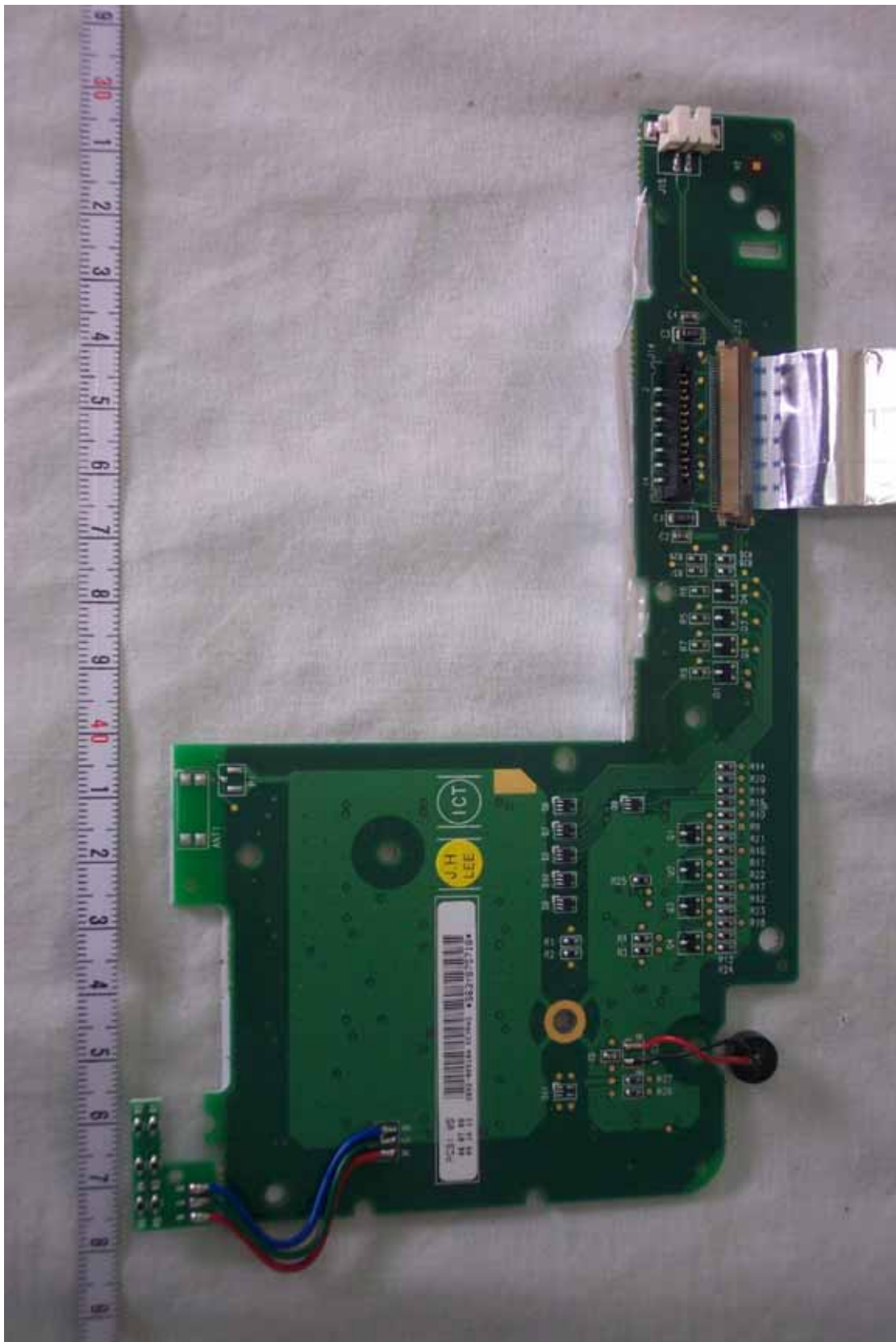
● Rear View of LCD



- Front View of Key Panel



- Rear View of Key Panel



- Front View of Wireless LAN module



- Front View of Wireless LAN module



- Rear View of Wireless LAN module



- Enclosure View of Adaptor



● Label View of Adaptor



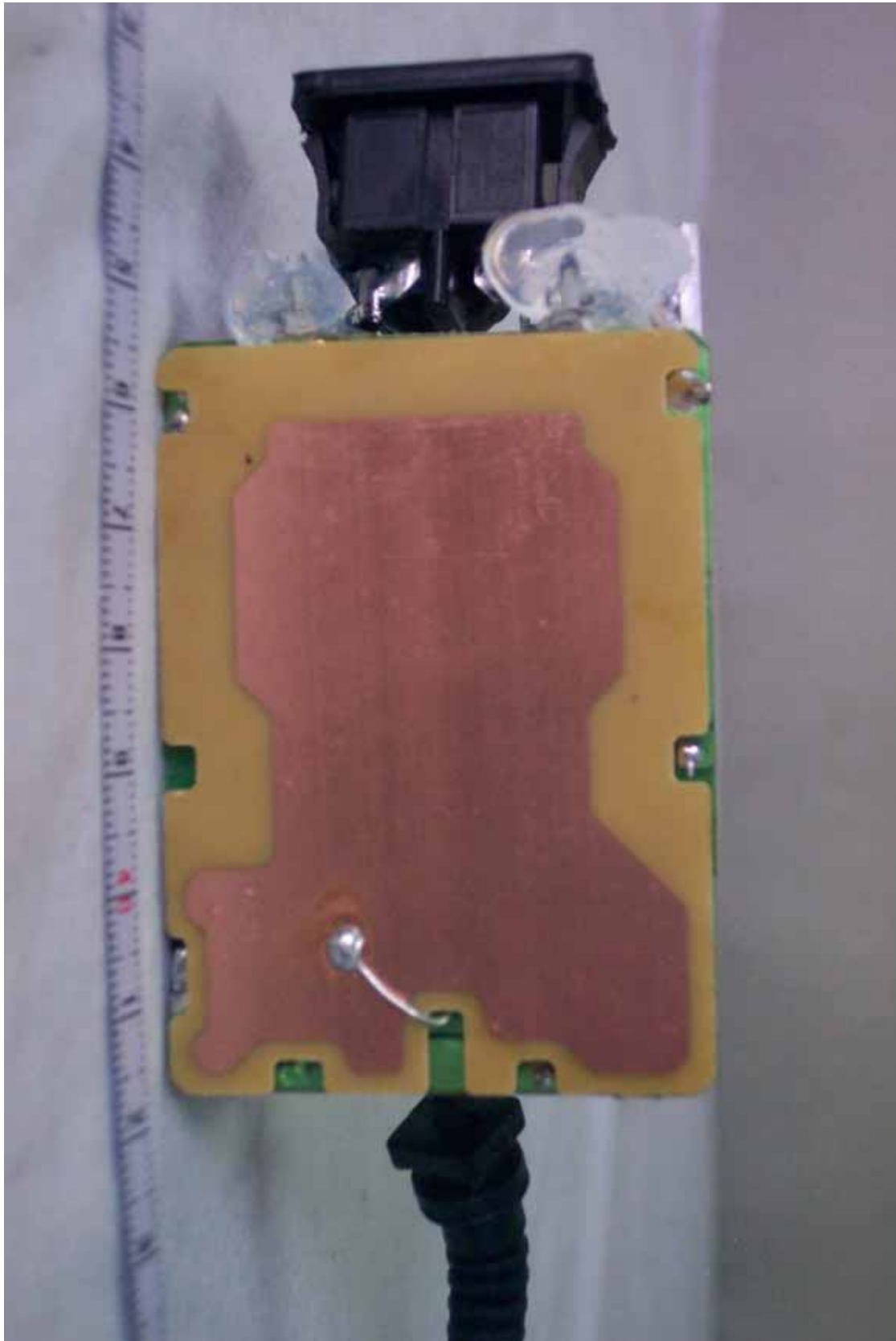
- Inside View of Adaptor



- Front View of Adaptor Board



- Rear View of Adaptor Board



APPENDIX E– CIRCUIT DIAGRAM

APPENDIX F – USER’S MANUAL

APPENDIX G – Operating Description
